

PRODUCT DISCONTINUANCE NOTIFICATION

EOL-000172

Date: 22SEP2017 P1/3

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Semtech Corporation, 200 Flynn Road, Camarillo CA 93012						
 Semtech Canada Corporation, 4281 Harvester Road, Burlington, Ontario L7L 5M4 Canada Semtech Irvine, 5141 California Ave., Suite 100, Irvine CA 92617 						
Semtech Neuchatel Sarl,			hatal Switzerla	nd		
Semtech Bristol, Nanoted						
Semtech Corpus Christi						
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	Product Disc	ontinuance De	tails			
Purpose, Description a	and Effect of Chang	e:				
This notification is to inform y below. In accordance with S changes in order for your corsupply.	emtech's product discont	inuation policy, we	are hereby giv	ing notice of these product		
Part Number(s) Affects RClamp1821Z RClamp0531Z RClamp0542Z uClamp0512Z		Customer Part	: Number(s)	Affected: ⊠ N/A		
Replacement or Altern RClamp1821Z ⇒RClamp185 RClamp0531Z ⇒RClamp503 RClamp0542Z ⇒RClamp054 μClamp0512Z ⇒μClamp051	51ZA 31ZA or RClamp5011ZA 42ZA	□ N/A	or Not Offered			
Last Time Buy (LTB) Date	21MAR2018		ept Final ery by	22SEP2018		
Sample Availability of Alt. Part	22SEP2017 🗌 N/A		on Report of Alt. Part	22SEP2017 N/A		
Supporting DocumentData SheetQualification Report		eplacement pa	rts/Attachm	ents:		
Last Time Buy Conditions						
We request you carefully review this information and notify your purchasing offices and buyers to place your company's final purchases for available discontinued products as soon as possible according to the following last time buy terms and conditions.						
orders must have be rejected. The	e Last Time Buy Date a e a requested ship date e Last Time Buy Date au een scheduled and sold	before the Date to tomatically expire	o Accept Final	<i>Delivery</i> or the order will		

2. **Pricing:** The product unit price will be subject to Semtech's individual price quotation of your

company's last time buy requirements.



PRODUCT DISCONTINUANCE NOTIFICATION

EOL-000172

Date: 22SEP2017 P2/3

3. Order Acceptance/Change Conditions:

- A. Semtech will accept last time orders from your company for the discontinued products as "Firm and Final". As such, these orders will not be subject to any reschedule, cancellation, or termination by your company without Semtech's prior written authorization and payment of full termination charges.
- B. Semtech reserves its right to make changes in the scheduled delivery dates, or to terminate remaining undelivered quantities of your company's last time buy order, due to changes in Semtech's last time manufacturing capabilities, or for commercially impracticable circumstances which makes delivery not feasible.
- 4. **Quantities:** The following applies to final buy quantities for the available discontinued product:
 - A. **First:** The quantities in any existing unfilled orders and contracts acknowledged by Semtech will be honored, then
 - B. **Next:** The unfilled quantities in any volume agreement(s) or quantities in unexpired standalone quote(s) will be accepted, and
 - C. **Finally:** Any additional reasonable quantity of product that Semtech quotes based upon your company's identified requirements will be taken.

IN THE EVENT OF CONFLICT FOR THE LIMITED AVAILABILITY PRODUCT, QUANTITIES FOR CUSTOMER'S OR DISTRIBUTOR'S ORDERS WILL BE DETERMINED ON A FIRST-COME FIRST-SERVE BASIS; AND WILL BE SUBJECT TO SEMTECH'S AVAILABLE INVENTORY AND REMAINING MANUFACTURING CAPACITY FOR THE PRODUCT.

Limited Warranty

All discontinued product orders subject to this notice shall carry Semtech's standard limited warranty; or, if applicable, the warranty set forth in a duly executed formal contract between Semtech and your company will apply; except that:

- 1. Semtech will accept all valid warranty claims for credit only, unless a replacement order is otherwise agreed upon by Semtech and the replacement parts can be manufactured or delivered from remaining inventory.
- 2. The applicable warranty period for making any return claims for discontinued products will be no later than ninety (90) days following delivery of the discontinued products.
- 3. Any return claims must be made under Semtech's current Return Material Authorization "RMA" procedures.

Additional Provisions

SEMTECH ACCEPTS NO LIABILITY FOR EXCESS REPROCUREMENT COSTS OR FOR ANY SPECIAL, INCIDENTAL, OR CONSEQUENTIAL DAMAGES WHATSOEVER ASSOCIATED WITH THIS NOTICE, WITH ITS PRODUCTS, OR WITH THE FINAL MANUFACTURE AND PERFORMANCE AGAINST ANY LAST TIME BUY ORDERS RELATED TO THE DISCONTINUED PRODUCTS COVERED BY THIS NOTICE.

We regret the inconvenience and impact this notice may cause your company. Semtech's sales, marketing, and distribution personnel stand ready to assist you in placing your company's final orders, or in providing the product information you require.

For product inquiries or purchase order information, please contact your local Semtech sales representative.



PRODUCT DISCONTINUANCE NOTIFICATION

EOL-000172

Date: 22SEP2017 P3/3

	Issuing Authority	
Semtech Business Unit:		
Semtech Contact Info:	Les Fang Yuen Semtech Corporation Quality Assurance 200 Flynn Road Camarillo, CA 93012 Ifangyuen@semtech.com Office: (949) 269-4443 Fax: (805) 498-3804	Les Long ynen

RClamp1851ZA Ultra Small RClamp® 1-Line, 18V ESD Protection

PROTECTION PRODUCTS - RailClamp®

Description

RClamp® TVS diodes are designed to protect sensitive electronics from damage or latch-up due to ESD. They are designed to replace multilayer varistors (MLVs) in portable applications such as cell phones, notebook computers, and other portable electronics. This device offers desirable characteristics for board level protection including fast response time, low operating and clamping voltage, and no device degradation.

RClamp®1851ZA is specifically designed for protection of Near Field Communications (NFC) interfaces. It features extremely good ESD protection characteristics including a low typical dynamic resistance of 0.16 Ohms, low peak ESD clamping voltage, and high ESD withstand voltage (+/-17kV contact per IEC 61000-4-2). Low typical capacitance (0.35pF at VR=0V) means that harmonic distortion the the RF signal is minimized. This device is bidirectional and has a working voltage of 18V for use on NFC resonator circuits without signal clipping.

RClamp1851ZA is in a 2-pin SLP0603P2X3F package measuring 0.6 x 0.3 mm with a nominal height of only 0.25mm. Leads are finished with NiAu. The small package gives the designer the flexibility to protect single lines in applications where arrays are not practical. The combination of small size and high ESD surge capability makes them ideal for use in portable applications such as cellular phones, digital cameras, and tablet PC's.

Features

- ◆ High ESD withstand Voltage: +/-17kV (Contact) and +/- 20kV (Air) per IEC 61000-4-2
- ◆ Ultra-small package
- Protects one high speed data line
- Low ESD clamping voltage
- Working voltage: 18V
- Low capacitance: 0.35pF typical
- ◆ Low leakage current
- Extremely low dynamic resistance: 0.16 Ohms (Typ)
- Solid-state silicon-avalanche technology

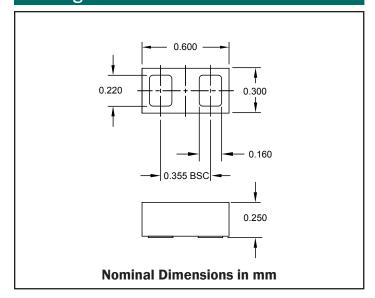
Mechanical Characteristics

- SLP0603P2X3F package
- Pb-Free, Halogen Free, RoHS/WEEE Compliant
- ◆ Nominal Dimensions: 0.6 x 0.3 x 0.25 mm
- Lead Finish: NiAu
- Marking: Marking code
- Packaging: Tape and Reel

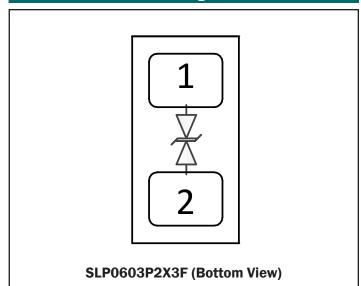
Applications

- Near Field Communication (NFC) lines
- RF signal lines
- Cellular Handsets
- Tablets
- FM Antenna

Package Dimensions



Schematic & Pin Configuration





Absolute Maximum Ratings

Rating	Symbol	Value	Units
Peak Pulse Current (tp = 8/20μs)	I _{PP}	3	Α
ESD per IEC 61000-4-2 (Air) ⁽¹⁾ ESD per IEC 61000-4-2 (Contact) ⁽¹⁾	V _{ESD}	±20 ±17	kV
Operating Temperature	T _J	-40 to +85	°C
Storage Temperature	T _{STG}	-55 to +150	°C

Electrical Characteristics (T=25°C unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Units
Reverse Stand-Off Voltage	V _{RWM}	$T = -40 \text{ to } +85^{\circ}\text{C}$			18	V
Breakdown Voltage	V _{BR}	I _{BR} = 10μA	18.5	22.5	26.5	V
Reverse Leakage Current	I _R	V _{RWM} = 18V		<1	50	nA
ESD Clamping Voltage ²	V _c	$I_{pp} = 4A$ tp = 0.2/100ns		5.5		V
ESD Clamping Voltage ²	V _c	$I_{pp} = 16A$ tp = 0.2/100ns		7.5		V
Dynamic Resistance ^{2, 3}	R _{DYN}	tp = 0.2/100ns		0.16		Ohms
Junction Capacitance	C _J	VR = OV; f = 1MHz		0.35	0.45	pF

Notes

¹⁾Measured with a 40dB attenuator, 50 Ohm scope input impedance, 2GHz bandwidth. ESD gun return path connected to ESD ground plane.

²⁾Transmission Line Pulse Test (TLP) Settings: tp = 100ns, tr = 0.2ns, I_{TLP} and V_{TLP} averaging window: t1 = 70ns to t2 = 90ns.

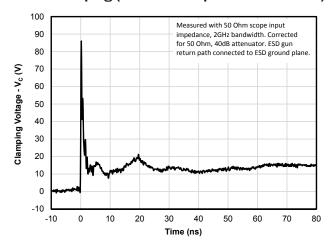
³⁾Dynamic resistance calculated from $\rm I_{\rm TLP}$ = 4A to $\rm I_{\rm TLP}$ = 16A

⁴⁾Device is electrically symmetrical

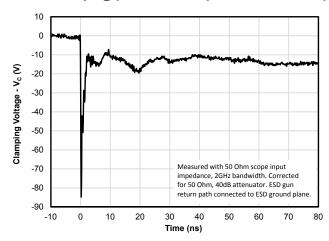


Typical Characteristics

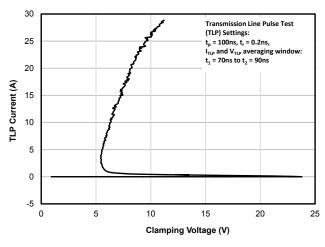
ESD Clamping (8kV Contact per IEC 61000-4-2)



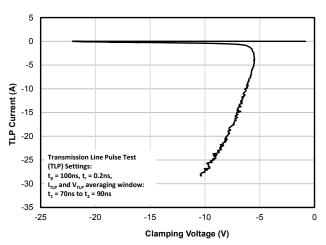
ESD Clamping (-8kV Contact per IEC 61000-4-2)



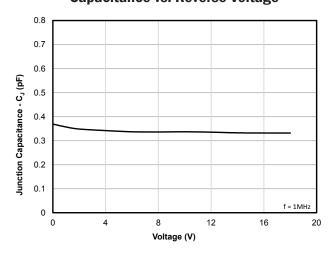
TLP Characteristic (Positive Pulse)



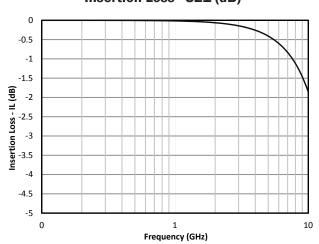
TLP Characteristic (Negative Pulse)



Capacitance vs. Reverse Voltage



Insertion Loss - S21 (dB)





Applications Information

ESD Protection of NFC Interfaces

The Near Field Communication (NFC) antenna is usually connected to the NFC controller IC via contact points on the phone. These contact points are user accessable and therefore may be subjected to ESD strikes. External protection (TVS) devices should be placed between the antenna and the NFC chip interface. The working voltage of the TVS should be high enough as not to clip the NFC signal. Additionally, the capacitance of the device

should be minimized in order to avoid harmonic disctortion of the RF signal. RClamp1851ZA meets these requirements and also features extremely low dynamic resistance resulting in low ESD clamping voltage. The low dynamic resistance also helps insure protection for Schottky diodes that may be used in the NFC circuit. RClamp1851ZA is designed to work on NFC circuits with AC signals as high as 18V. An example protection ciruit is shown below in Figure 1.

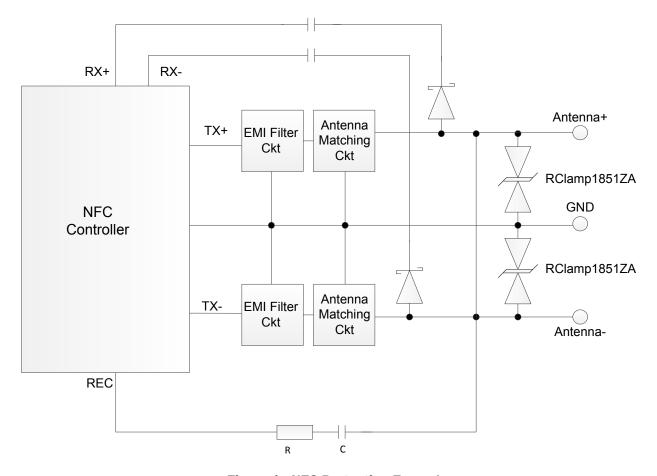


Figure 1 - NFC Protection Example

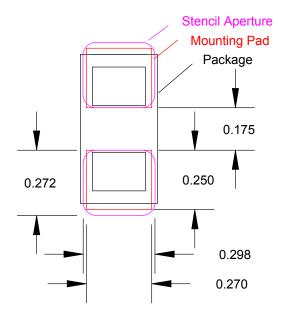


Applications Information

Assembly Guidelines

The small size of this device means that some care must be taken during the mounting process to insure reliable solder joint. The table below provides Semtech's recommended assembly guidelines for mounting this device. The figure at the right details Semtech's recommended aperture based on the below recommendations. Note that these are only recommendations and should serve only as a starting point for design since there are many factors that affect the assembly process. The exact manufacturing parameters will require some experimentation to get the desired solder application.

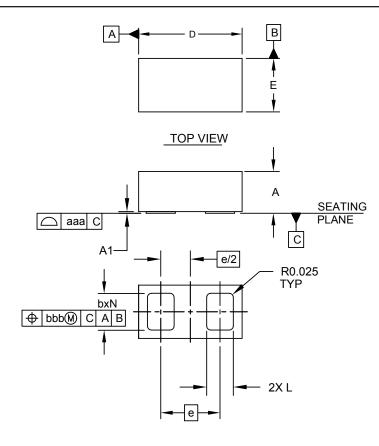
Assembly Parameter	Recommendation
Solder Stencil Design	Laser cut, Electro-polished
Aperture shape	Rectangular with rounded corners
Solder Stencil Thickness	0.100 mm (0.004")
Solder Paste Type	Type 4 size sphere or smaller
Solder Reflow Profile	Per JEDEC J-STD-020
PCB Solder Pad Design	Non-Solder mask defined
PCB Pad Finish	OSP OR NiAu



Recommended Mounting Pattern



Outline Drawing - SLP0603P2X3F



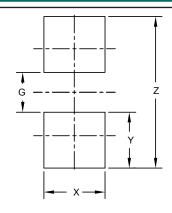
DIMENSIONS					
DIM	MILI	_IMETE	RS		
וואווטן	MIN	NOM	MAX		
Α	0.235	0.250	0.265		
A1	0.000	0.010	0.050		
р	0.200	0.220	0.240		
D	0.580	0.600	0.620		
Е	0.280	0.300	0.320		
е	0.355 BSC				
L	0.140	0.160	0.180		
Ζ	2				
aaa	0.08				
bbb		0.10			

BOTTOM VIEW

NOTES:

1. CONTROLLING DIMENSIONS ARE IN MILLIMETERS (ANGLES IN DEGREES).

Land Pattern - SLP0603P2X3F



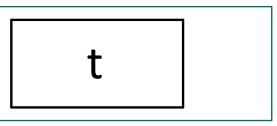
DIMENSIONS				
DIM MILLIMETERS				
G	0.177			
Х	0.272			
Υ	0.247			
Z	0.671			

NOTES:

CONTROLLING DIMENSIONS ARE IN MILLIMETERS (ANGLES IN DEGREES). THIS LAND PATTERN IS FOR REFERENCE PURPOSES ONLY.
CONSULT YOUR MANUFACTURING GROUP TO ENSURE YOUR
COMPANY'S MANUFACTURING GUIDELINES ARE MET.



Marking



Notes: Device is Electrically Symmetrical

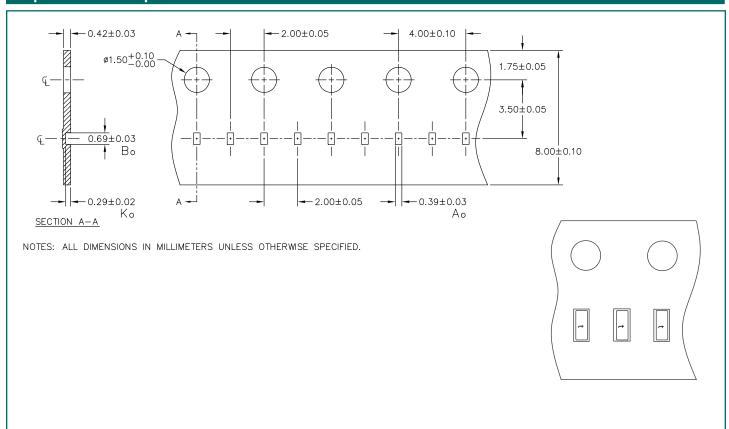
Ordering Information

Part Number	Qty per Reel	Reel Size
RClamp1851ZATFT	15000	7"

Notes:

1) RailClamp and RClamp are trademarks of Semtech Corporation.

Tape and Reel Specification



Contact Information

Semtech Corporation Protection Products Division 200 Flynn Rd., Camarillo, CA 93012 Phone: (805)498-2111 FAX (805)498-3804



RClamp5031ZA Ultra Small RClamp® 1 Line, 5V ESD Protection

PROTECTION PRODUCTS

Description

RClamp® TVS diodes are designed to protect sensitive electronics from damage or latch-up due to ESD. They are designed to replace 0201 size multilayer varistors (MLVs) in portable applications such as cell phones, notebook computers, and other portable electronics. This device offers desirable characteristics for board level protection including fast response time, low operating and clamping voltage, and no device degradation.

RClamp°5031ZA features extremely good ESD protection characteristics highlighted by low typical dynamic resistance of 0.17 Ohms, low peak ESD clamping voltage, and high ESD withstand voltage (+/-17kV contact per IEC 61000-4-2). Low maximum capacitance (0.45pF at VR=0V) minimizes loading on sensitive cirucuits. Each device will protect one high-speed data line operating at 5 Volts.

RClamp5031ZA is in a 2-pin SLP0603P2X3F package measuring 0.6 x 0.3 mm with a nominal height of only 0.25mm. Leads are finished with NiAu. The small package gives the designer the flexibility to protect single lines in applications where arrays are not practical. The combination of small size and high ESD surge capability makes them ideal for use in portable applications.

Features

- High ESD withstand Voltage: +/-17kV (Contact) per IEC 61000-4-2 and +/- 24kV (air) per IEC 61000-4-2
- Ultra-small package
- · Protects one data line
- · Low ESD clamping voltage
- Working voltage: 5V
- Low capacitance: 0.45pF maximum
- Low leakage current
- Low dynamic resistance: 0.17 Ω (typ)
- · Solid-state silicon-avalanche technology

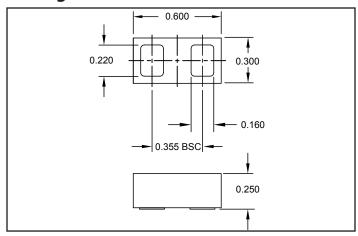
Mechanical Characteristics

- SLP0603P2X3F package
- Pb-Free, Halogen Free, RoHS/WEEE compliant
- Nominal Dimensions: 0.6 x 0.3 x 0.25 mm
- Lead Finish: NiAu
- Marking: Marking code
- Packaging: Tape and Reel

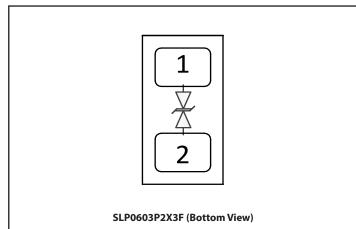
Applications

- USB3.0
- USB Type-C
- MiPi/MDDI
- MHL
- FM antenna
- Wearables

Package Dimension



Schematic & Pin Configuration



Absolute Maximum Rating

Rating	Symbol	Value	Units
Peak Pulse Current (tp = 1.2/50μs)	I _{PP}	4	А
ESD per IEC 61000-4-2 (Air) ⁽²⁾ ESD per IEC 61000-4-2 (Contact) ⁽²⁾	V _{ESD}	±24 ±17	kV
Operating Temperature	T _J	-40 to +85	∘C
Storage Temperature	T _{STG}	-55 to +150	°C

Electrical Characteristics (T=25°C unless otherwise specified)

Parameter	Symbol	Conditions		Min.	Тур.	Max.	Units
Reverse Stand-Off Voltage	V _{RWM}					5	V
Reverse Breakdown Voltage	V _{BR}	I _t = 10mA		6.5	8.5	10.5	V
Holding Current	I _H	V=V _H			100		mA
Reverse Leakage Current	I _R	$V_{RWM} = 5V$			<5	50	nA
Clamping Voltage	V _C	tp = 8/20µs	I _{PP} = 4A			13	V
ESD Clamping Valtage?	V	tp = 0.2/100ns	I _{PP} = 4A		5		V
ESD Clamping Voltage ²	V _C	τρ – 0.2/100115	I _{PP} = 16A		7		V
Dynamic Resistance ^{2,3}	R _{DYN}	tp = 0.2/100ns			0.17		Ω
Junction Capacitance	C _J	$V_R = 0V, f = 1MHz$	T = 25°C		0.35	0.45	pF

Notes

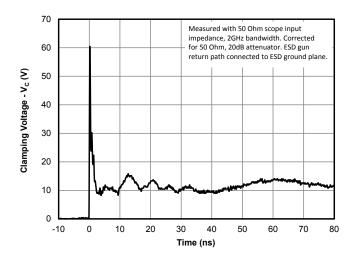
¹⁾ Measured with a 20dB attenuator, 50 Ohm scope input impedance, 2GHz bandwidth. ESD gun return path connected to ESD ground plane.

²⁾ Transmission Line Pulse Test (TLP) Settings: tp = 100ns, tr = 0.2ns, I_{TLP} and V_{TLP} averaging window: t1 = 70ns to t2 = 90ns.

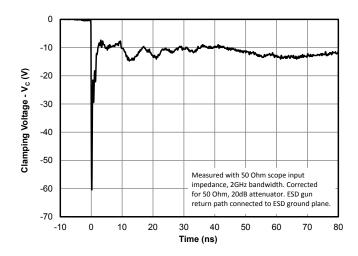
³⁾ Dynamic resistance calculated from $\rm I_{\rm TLP} = 4A$ to $\rm I_{\rm TLP} = 16A$

Typical Characteristics

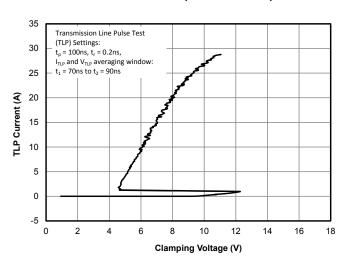
ESD Clamping (8kV Contact per IEC 61000-4-2)



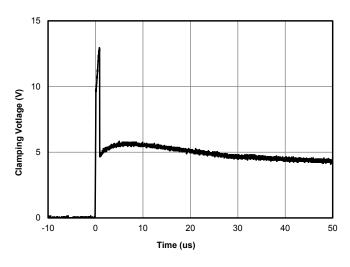
ESD Clamping (-8kV Contact per IEC 61000-4-2)



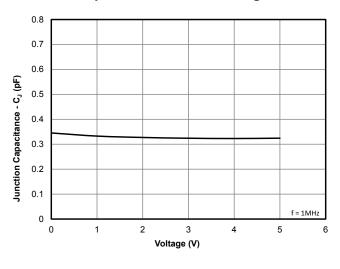
TLP Characteristic (Positive Pulse)



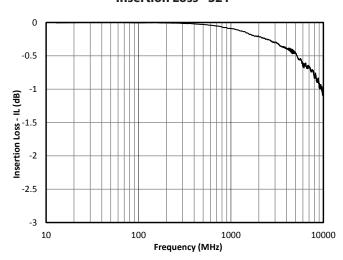
Clamping Voltage Waveform (tp=1.2/50µs)



Capacitance vs. Reverse Voltage

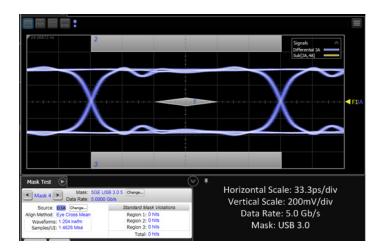


Insertion Loss - S21

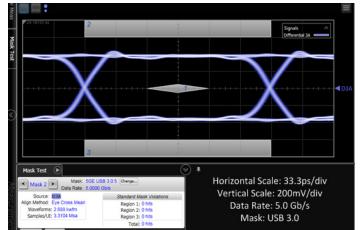


Typical Characteristics (Continued)

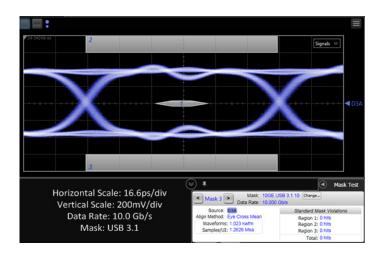
5Gb/s (USB 3.0) Eye Diagram with RClamp5031ZA



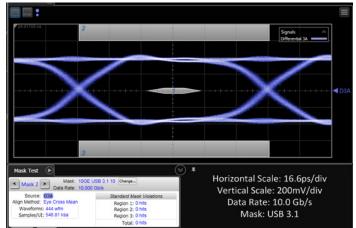
5Gb/s (USB 3.0) Eye Diagram without RClamp5031ZA



10Gb/s (USB 3.1) Eye Diagram with RClamp5031ZA



10Gb/s (USB 3.1) Eye Diagram without RClamp5031ZA



Application Information

Assembly Guidelines

The small size of this device means that some care must be taken during the mounting process to insure reliable-solder joints. The figure at the right details Semtech's recommended mounting pattern. Recommended assembly guidelines are shown in Table 1. Note that these are only recommendations and should serve only as a starting point for design since there are many factors that affect the assembly process. Exact manufacturing-parameters will require some experimentation to get the desired solder application. Semtech's recommendedmounting pattern is based on the following design guidelines:

Land Pattern

The recommended land pattern follows IPC standards and is designed for maximum solder coverage. Detailed dimensions are shown elsewhere in this document.

Solder Stencil

Stencil design is one of the key factors which will determine the volume of solder paste which is deposited onto the land pad. The area ratio of the stencil aperture will determine how well the stencil will print. The area ratio takes into account the aperture shape, aperture size, and stencil thickness. An area

ratio of 0.70 – 0.75 is preferred for the subject package. The area ratio of a rectangular aperture is given as:

Area Ratio = (L * W) / (2 * (L + W) * T)

Where:

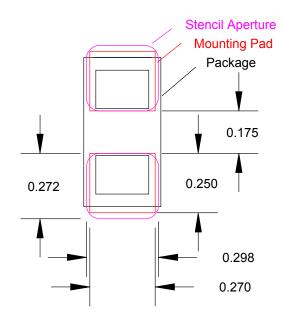
L = Aperture Length

W = Aperture Width

T = Stencil Thickness

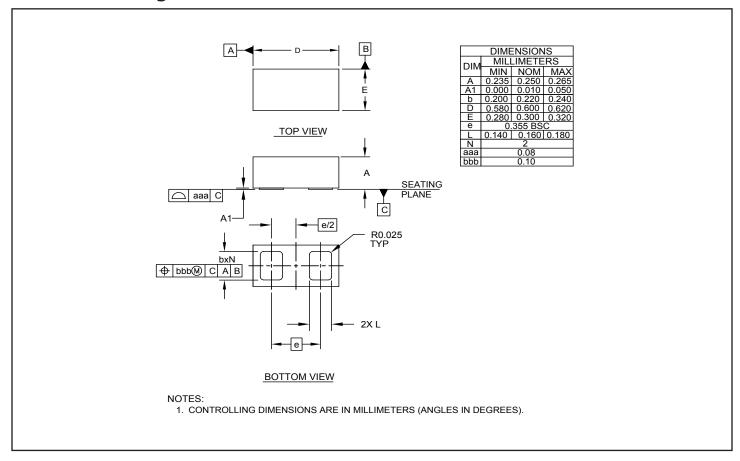
Semtech recommends a stencil thickness of 0.100mm for this device. The stencil should be laser cut with electropolishedfinish. The stencil should have a positive taper of approximately 5 degrees. Electro polishing and tapering the walls results in reduced surface friction and better paste release. For small pitch components, Semtech recommends a square aperture with rounded corners for consistent solder release. Due to the small aperture size, a solder paste withType 4 or smaller particles are recommended.

Recommended Mounting Pattern

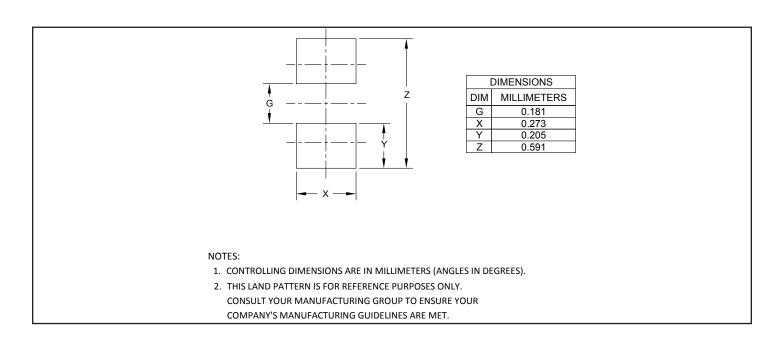


Assembly Parameter	Recommendation
Solder Stencil Design	Laser cut, Electro-polished
Aperture shape	Rectangular with rounded corners
Solder Stencil Thickness	0.100 mm (0.004")
Solder Paste Type	Type 4 size sphere or smaller
Solder Reflow Profile	Per JEDEC J-STD-020
PCB Solder Pad Design	Non-Solder mask defined
PCB Pad Finish	OSP OR NiAu

Outline Drawing - SLP0603P2X3F



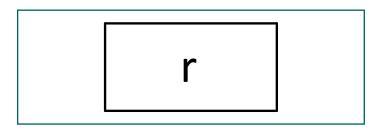
Land Pattern - SLP0603P2X3F



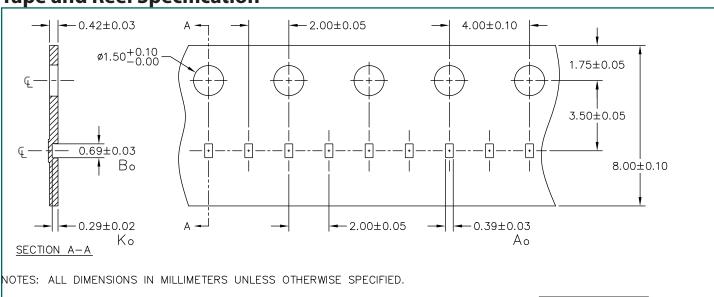
Rev 3.0

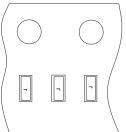
6/9/2015

Marking Code



Tape and Reel Specification





Ordering Information

Part Number	Qty per Reel	Reel Size
RClamp5031ZATFT	15,000	7"



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Contact Information

Semtech Corporation 200 Flynn Road, Camarillo, CA 93012 Phone: (805) 498-2111, Fax: (805) 498-3804 www.semtech.com



RClamp5011ZA Ultra Small RailClamp® 1-Line, 5V ESD Protection

PROTECTION PRODUCTS

Description

RailClamp® TVS diodes are designed to protect sensitive electronics from damage or latch-up due to ESD. They are designed to replace 0201 size multilayer varistors (MLVs) in portable applications such as cell phones, notebook computers, and other portable electronics. This device offers desirable characteristics for board level protection including fast response time, low operating and clamping voltage, and no device degradation.

RClamp®5011ZA features extremely good ESD protection characteristics highlighted by low typical dynamic resistance of 0.25 Ohms, low peak ESD clamping voltage, and high ESD withstand voltage (+/-15kV contact per IEC 61000-4-2). Low maximum capacitance (0.45pF at VR=0V) minimizes loading on sensitive cirucuits. Each device will protect one high-speed data line operating at 5 Volts.

RClamp5011ZA is in a 2-pin SLP0603P2X3F package measuring 0.6 x 0.3 mm with a nominal height of only 0.25mm. Leads are finished with NiAu. The small package gives the designer the flexibility to protect single lines in applications where arrays are not practical. The combination of small size and high ESD surge capability makes them ideal for use in applications such as cellular phones, displays, and tablet PC's.

Features

- High ESD withstand Voltage: +/-15kV (Contact) and +/- 18kV (Air) per IEC 61000-4-2
- Ultra-small package
- · Protects one data line
- Low ESD clamping voltage
- Working voltage: 5V
- Low capacitance: 0.45pF maximum
- Low leakage current
- Extremely low dynamic resistance: 0.25 Ohms (Typ)
- Solid-state silicon-avalanche technology

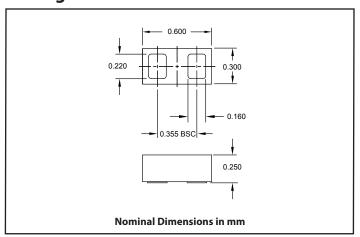
Mechanical Characteristics

- SLP0603P2X3F package
- Pb-Free, Halogen Free, RoHS/WEEE Compliant
- Nominal Dimensions: 0.6 x 0.3 x 0.25 mm
- · Lead Finish: NiAu
- · Marking: Marking code
- Packaging: Tape and Reel

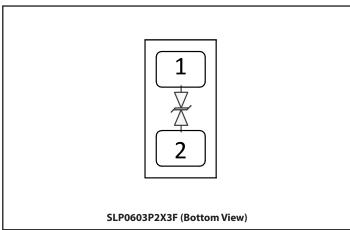
Applications

- HDMI
- USB 3.0
- · MiPi / MDDI
- MHL
- FM Antenna

Package Dimension



Schematic & Pin Configuration



Absolute Maximum Rating

Rating	Symbol	Value	Units
Peak Pulse Power ($t_p = 8/20 \mu s$)	P _{PK}	50	W
Peak Pulse Current ($t_p = 8/20\mu s$)	I _{PP}	4	А
ESD per IEC 61000-4-2 (Air) ⁽¹⁾ ESD per IEC 61000-4-2 (Contact) ⁽¹⁾	V _{ESD}	±18 ±15	kV
Operating Temperature	T _J	-40 to +85	∘C
Storage Temperature	T _{STG}	-55 to +150	°C

Electrical Characteristics (T=25°C unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Units
Reverse Stand-Off Voltage	V _{RWM}	T=-40 to +85°C			5	٧
Reverse Breakdown Voltage	V _{BR}	$I_{pT} = 1 \text{mA}$	6.5	7.5	10	V
Reverse Leakage Current	I _R	$V_{RWM} = 5V$		<5	50	nA
Clamping Voltage	V	$I_{pp} = 2A, t_p = 8/20 \mu s$			11.5	V
	V _C	$I_{pp} = 4A, t_p = 8/20 \mu s$			12.5	V
FCD Clamping Valtage (2)	V	$I_{pp} = 4A, t_p = 0.2/100$ ns		8.5		V
ESD Clamping Voltage ⁽²⁾ V _C	V _C	$I_{pp} = 16A, t_p = 0.2/100$ ns		11.5		V
Dynamic Resistance ^{(2), (3)}	R _{DYN}	$t_p = 0.2/100$ ns		0.25		Ω
Junction Capacitance	C _J	$V_R = 0V, f = 1MHz$		0.40	0.45	pF

Notes

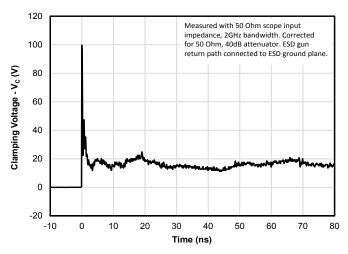
 $^{1) \} Measured \ with \ a \ 40 dB \ attenuator, 50 \ Ohm \ scope \ input \ impedance, 2 GHz \ bandwidth. \ ESD \ gun \ return \ path \ connected \ to \ ESD \ ground \ plane.$

²⁾ Transmission Line Pulse Test (TLP) Settings: tp = 100ns, tr = 0.2ns, I_{TLP} and V_{TLP} averaging window: t1 = 70ns to t2 = 90ns.

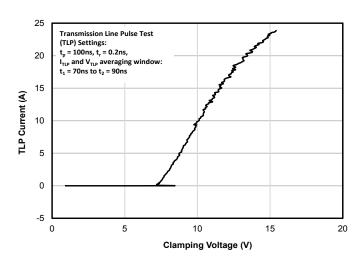
³⁾ Dynamic resistance calculated from $I_{TLP} = 4A$ to $I_{TLP} = 16A$

Typical Characteristics

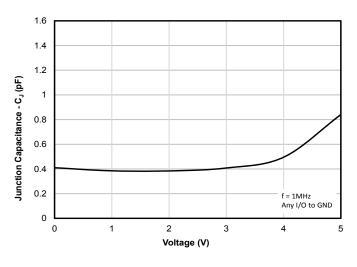
ESD Clamping (8kV Contact per IEC 61000-4-2)



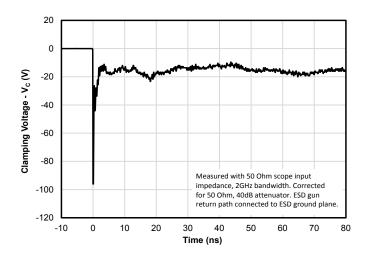
TLP Characteristic



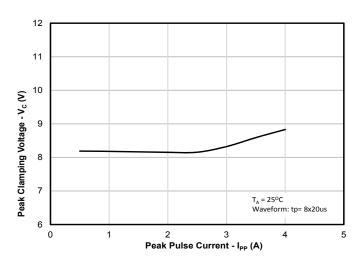
Capacitance vs. Reverse Voltage



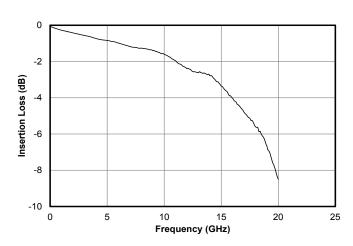
ESD Clamping (-8kV Contact per IEC 61000-4-2)



Clamping Voltage vs. Peak Pulse Current (t_o=8/20µs)

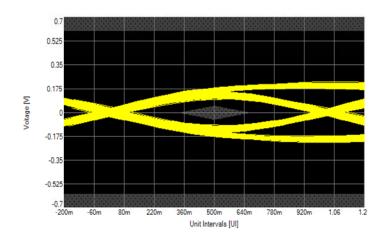


Insertion Loss-S21(dB)

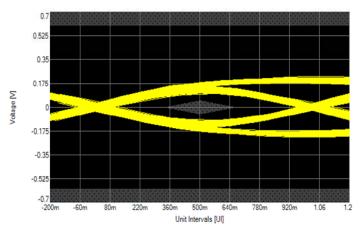


Typical Characteristics (Continued)

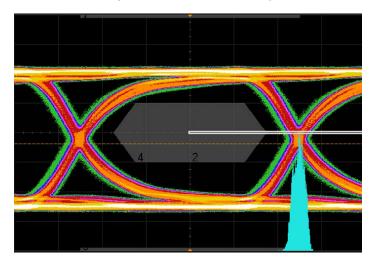
USB3.0 Eye Pattern without RClamp5011ZA



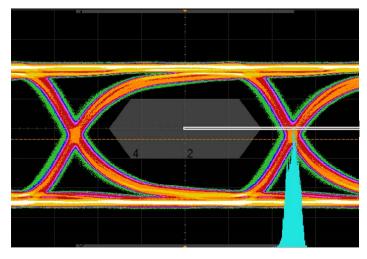
USB3.0 Eye Pattern with RClamp5011ZA



HDMI 1.4 Eye Pattern without RClamp5011ZA



HDMI 1.4 Eye Pattern with RClamp5011ZA



Application Information

Assembly Guidelines

The small size of this device means that some care must be taken during the mounting process to insure reliable-solder joints. The figure at the right details Semtech's recommended mounting pattern. Recommended assembly guidelines are shown in Table 1. Note that these are only recommendations and should serve only as a starting point for design since there are many factors that affect the assembly process. Exact manufacturing-parameters will require some experimentation to get the desired solder application. Semtech's recommendedmounting pattern is based on the following design guidelines:

Land Pattern

The recommended land pattern follows IPC standards and is designed for maximum solder coverage. Detailed dimensions are shown elsewhere in this document.

Solder Stencil

Stencil design is one of the key factors which will determine the volume of solder paste which is deposited onto the land pad. The area ratio of the stencil aperture will determine how well the stencil will print. The area ratio takes into account the aperture shape, aperture size, and stencil thickness. An area

ratio of 0.70 – 0.75 is preferred for the subject package. The area ratio of a rectangular aperture is given as:

Area Ratio = (L * W) / (2 * (L + W) * T)

Where:

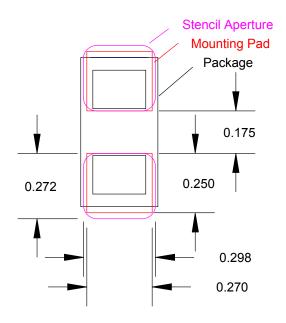
L = Aperture Length

W = Aperture Width

T = Stencil Thickness

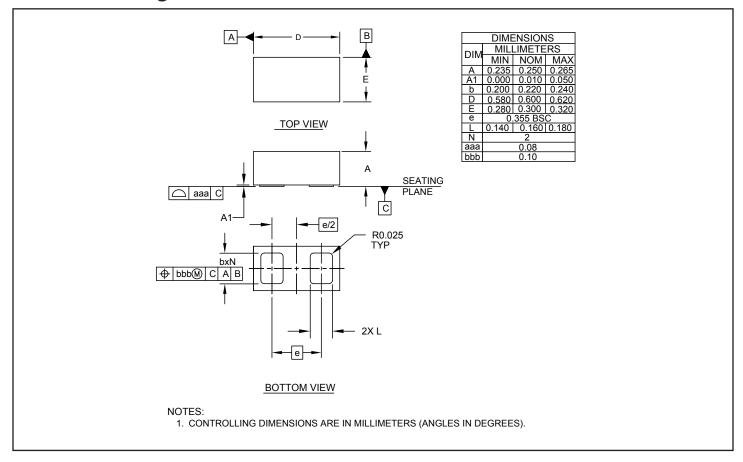
Semtech recommends a stencil thickness of 0.100mm for this device. The stencil should be laser cut with electropolishedfinish. The stencil should have a positive taper of approximately 5 degrees. Electro polishing and tapering the walls results in reduced surface friction and better paste release. For small pitch components, Semtech recommends a square aperture with rounded corners for consistent solder release. Due to the small aperture size, a solder paste with Type 4 or smaller particles are recommended.

Recommended Mounting Pattern

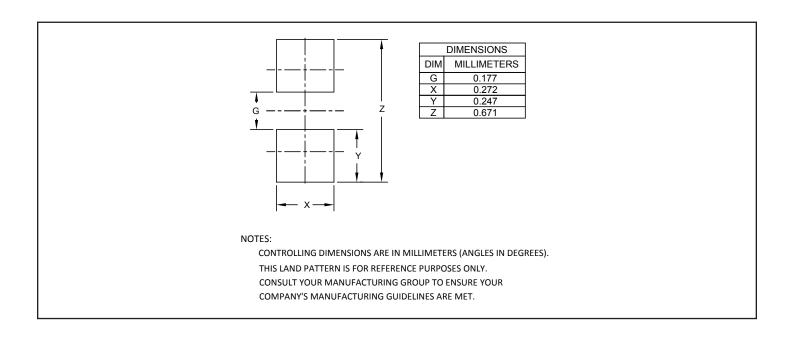


Assembly Parameter	Recommendation
Solder Stencil Design	Laser cut, Electro-polished
Aperture shape	Rectangular with rounded corners
Solder Stencil Thickness	0.100 mm (0.004")
Solder Paste Type	Type 4 size sphere or smaller
Solder Reflow Profile	Per JEDEC J-STD-020
PCB Solder Pad Design	Non-Solder mask defined
PCB Pad Finish	OSP OR NiAu

Outline Drawing - SLP0603P2X3F



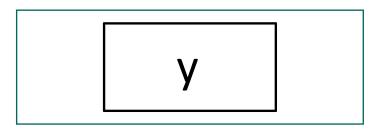
Land Pattern - SLP0603P2X3F



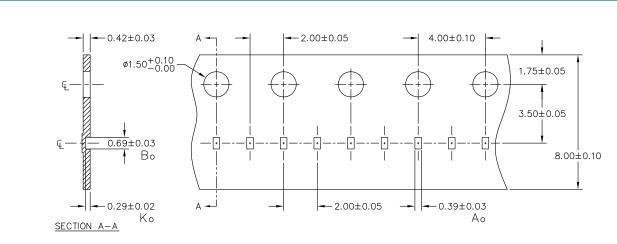
Rev 4.0

6/26/2015

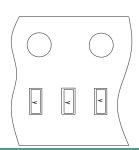
Marking Code



Tape and Reel Specification



NOTES: ALL DIMENSIONS IN MILLIMETERS UNLESS OTHERWISE SPECIFIED.



Ordering Information

Part Number	Qty per Reel	Reel Size				
RClamp5011ZATFT	15,000	7"				
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Contact Information

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RClamp0542ZA



Femto Farad RailClamp® 2-Line, 300fF ESD Protection

PROTECTION PRODUCTS

Description

RClamp®0542ZA is an ultra low capacitance ESD protection device designed to protect two high-speed lines in an 0201 footprint. This revolutionary package design reduces board space requirements by more than 50% over existing single line solutions. RClamp0542ZA is a three pin device with identical low capacitance TVS diodes connected to each pin. Any two pins may be connected to high-speed lines, while the third pin is connected to ground. This gives the designer maximum flexibility in pcb routing. Each line has a maximum capacitance of only 0.30pF resulting in a typical corner frequency of 12GHz.

RClamp0542ZA is in a 3-pin SLP0603P3X3F package. It measures 0.62×0.32 mm with a nominal height of only 0.25mm. Leads are finished with lead-free NiAu. The combination of small size and high ESD surge capability makes them ideal for use in portable applications such as cellular phones, digital cameras, and tablets.

Features

- High ESD withstand voltage
 - IEC 61000-4-2 (ESD) 17kV (air), 12kV (contact)
- Very small PCB area
- · Protects two high-speed data lines
- Working voltage: 5V
- Low reverse leakage current: <1nA typ at VR=5V
- Low capacitance: 0.30pF maximum
- Dynamic resistance: 1.17 Ohms (Typ)
- Solid-state silicon-avalanche technology

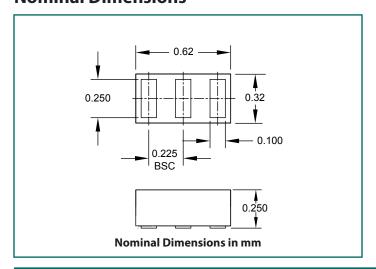
Mechanical Characteristics

- SLP0603P3X3F package
- Pb-Free, Halogen Free, RoHS/WEEE Compliant
- Nominal Dimensions: 0.62 x 0.32 x 0.25 mm
- Lead Finish: NiAu
- Marking: Marking code
- Packaging: Tape and Reel

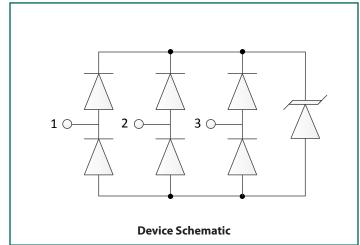
Applications

- High-Speed Lines
- MIPI / MDDI
- USB 3.0
- HDMI
- MHL
- eDP

Nominal Dimensions



Functional Schematic



Absolute Maximum Ratings

Rating	Symbol	Value	Units
Peak Pulse Power (tp = 8/20μs)	P _{PK}	40	W
Peak Pulse Current (tp = 8/20μs)	I _{PP}	2	A
ESD per IEC 61000-4-2 (Air) ⁽¹⁾ ESD per IEC 61000-4-2 (Contact) ⁽¹⁾	V _{ESD}	±17 ±12	kV
Operating Temperature	T,	-40 to +85	°C
Storage Temperature	T _{STG}	-55 to +150	оС

Electrical Characteristics (T=25°C unless otherwise specified)

Parameter	Symbol	Conditions		Min.	Тур.	Max.	Units
Reverse Stand-Off Voltage	V _{RWM}	-40°C to 85°C Between any two pins	-40°C to 85°C Between any two pins			5	V
Reverse Breakdown Voltage	V _{BR}	I _t = 10mA, Between any two pins	-40°C to 85°C	6.5	9.5	11.5	V
Doverso Lookaga Current		T=2	T = 25°C		0.01	0.050	μΑ
Reverse Leakage Current $I_R V_{RWM} = 5V$	T = 85°C		0.05	0.250	μΑ		
Clamping Voltage	V _c	1 '''	$I_{pp} = 2A$, $tp = 8/20\mu s$, Between any two pins		12	20	V
ESD Clamping Voltage ²	V _c	I _{pp} = 4A, tp = 0.2/100ns (TLP) Pin 1 to 2, Pin 3 to 2			16		V
ESD Clamping Voltage ²	V _c	I _{pp} = 16A, tp = 0.2/100ns (TLP) Pin 1 to 2, Pin 3 to 2			30		V
Dynamic Resistance ^{2, 3}	R _{DYN}	tp = 0.2/100ns (TLP) Pin 1 to 2, Pin 3 to 2			1.17		Ohms
Cut-Off Frequency	f _c	Insertion Loss (S21) = -3dB			12		GHz
Junction Capacitance	C _J	V _R = 0V, f = 1MHz Between any two pins	T = 25°C		0.27	0.30	pF
Change in Capacitance over VR	ΔC_{jVR}	VR = 0 - 5V, f = 1MHz				0.030	pF

Notes:

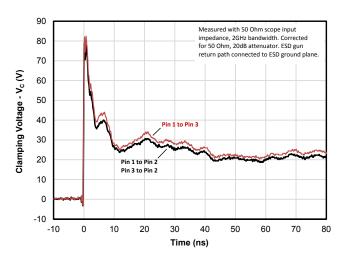
^{(1):} ESD Gun return path to Ground Reference Plane (GRP)

^{(2):} Transmission Line Pulse Test (TLP) Settings: tp = 100ns, tr = 0.2ns, I_{TLP} and V_{TLP} averaging window: t_1 = 70ns to t_2 = 90ns.

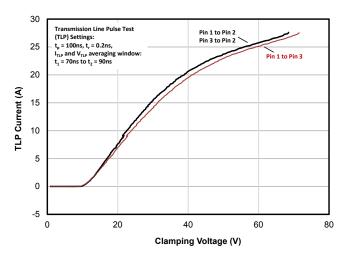
^{(3):} Dynamic resistance calculated from $I_{\rm TLP}$ = 4A to $I_{\rm TLP}$ = 16A

Typical Characteristics

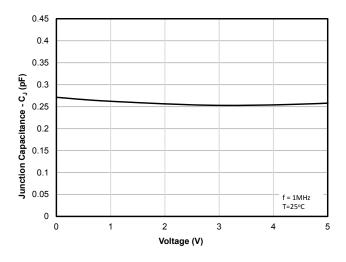
ESD Clamping (+8kV Contact per IEC 61000-4-2)



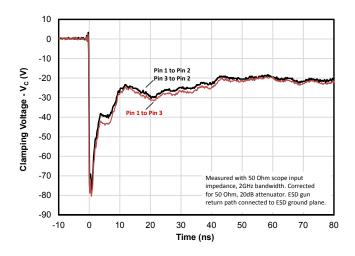
TLP IV Curve (Positive Pulse)



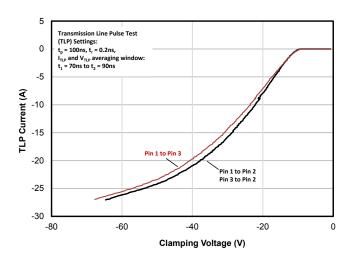
Capacitance vs. Reverse Voltage



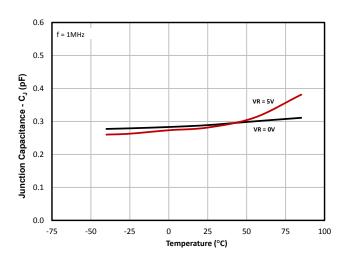
ESD Clamping (-8kV Contact per IEC 61000-4-2)



TLP IV Curve (Negative Pulse)

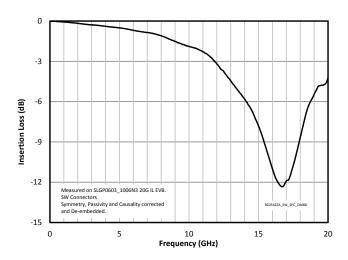


Capacitance vs. Temperature

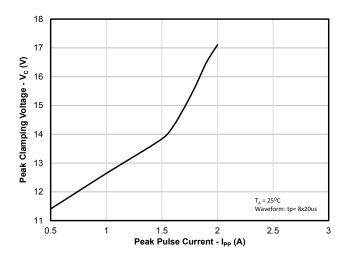


Typical Characteristics (Continued)

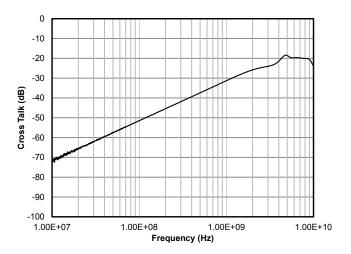
Insertion Loss - S21



Clamping Voltage vs. Peak Pulse Current (tp=8/20us)



Analog Crosstalk



Rev 2.0

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Applications Information

Assembly Guidelines

The small size of this device means that some care must be taken during the mounting process to insure reliable solder joint. The figure at the right details Semtech's recommended mounting pattern. Recommended assembly guidelines are shown in Table 1. Note that these are only recommendations and should serve only as a starting point for design since there are many factors that affect the assembly process. Exact manufacturing parameters will require some experimentation to get the desired solder application. Semtech's recommended mounting pattern is based on the following design guidelines:

Land Pattern

The recommended land pattern follows IPC standards and is designed for maximum solder coverage. Detailed dimensions are shown elsewhere in this document.

Solder Stencil

Stencil design is one of the key factors which will determine the volume of solder paste which is deposited onto the land pad. The area ratio of the stencil aperture will determine how well the stencil will print. The area ratio takes into account the aperture shape, aperture size, and stencil thickness. An area ratio of 0.70 – 0.75 is preferred for the subject package. The area ratio of a rectangular aperture is given as:

Area Ratio = (L * W) / (2 * (L + W) * T)

Where:

L = Aperture Length

W = Aperture Width

T = Stencil Thickness

Semtech recommends a stencil thickness of 0.100mm for this device. The stencil should be laser cut with electropolished finish. The stencil should have a positive taper of approximately 5 degrees. Electro polishing and tapering the walls results in reduced surface friction and better paste release. For small pitch components, Semtech recommends a square aperture with rounded corners for consistent solder release. Due to the small aperture size, a solder paste with Type 4 or smaller particles are recommended.

Recommended Mounting Pattern

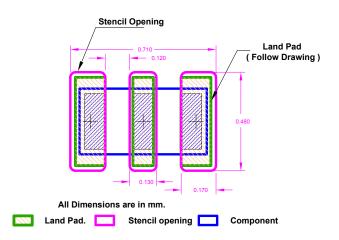
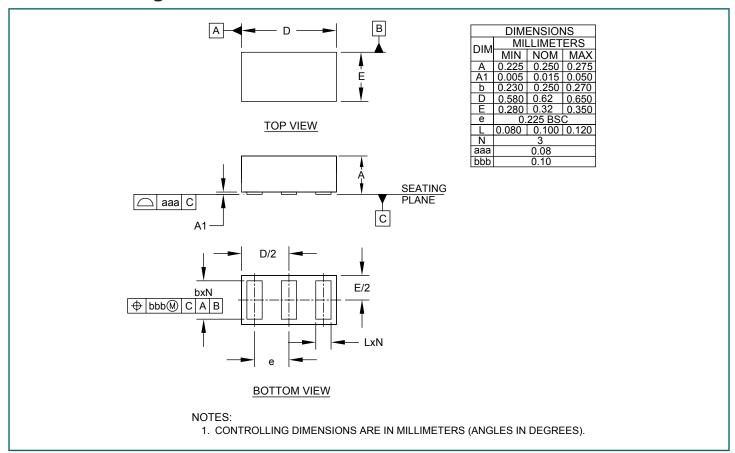


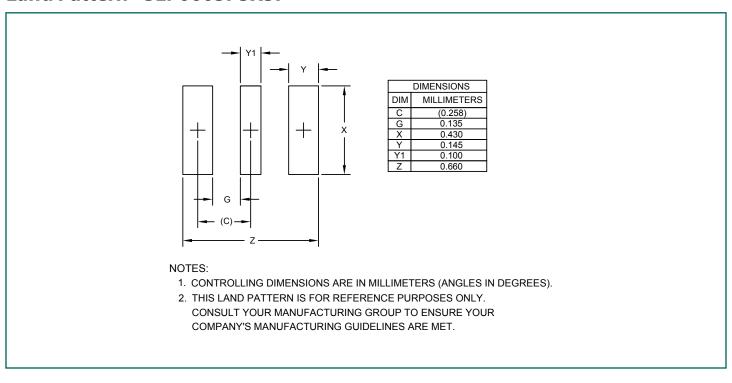
Table 1 - Recommended Assembly Guidelines					
Assembly Parameter	Recommendation				
Solder Stencil Design	Laser Cut, Electro-Polished				
Aperture Shape	Rectangular with rounded				
	corners				
Solder Stencil Thickness	0.100mm (0.004")				
Solder Paste Type	Type 4 size sphere or smaller				
Solder Reflow Profile	Per JEDEC J-STD-020				
PCB Solder pad Design	Non-Solder Mask Defined				
PCB Pad Finish	OSP or NiAu				

Outline Drawing - SLP0603P3X3F

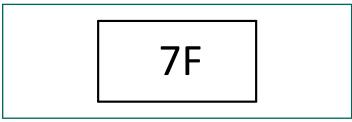


Land Pattern - SLP0603P3X3F

Rev 2.0

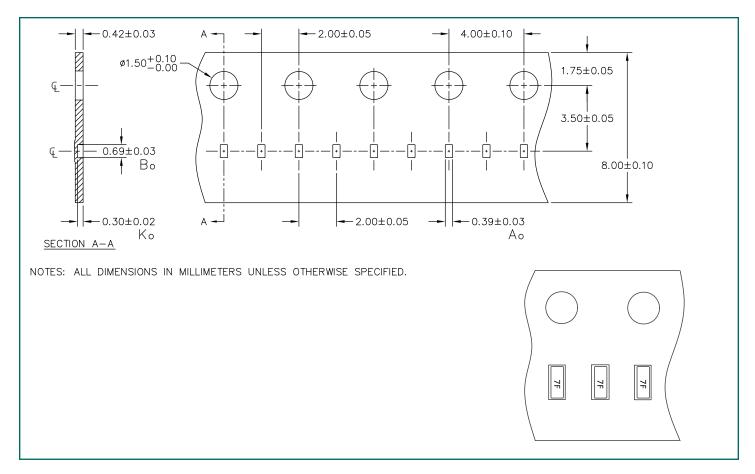


Marking Code



Notes: Device is electrically symmetrical

Tape and Reel Specification



Ordering Information

Part Number	Qty per Reel Reel Size				
RClamp0542ZATFT	15000	7 Inch			
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Rev 2.0



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Ultra Small μClamp® 2-Line ESD Protection

PROTECTION PRODUCTS

Description

uClamp®0512ZA is an ultra small ESD protection device designed to protect two high-speed lines in an 0201 footprint. This revolutionary package design reduces board space requirements by more than 50% over existing single line solutions. uClamp0512ZA is a three pin device with identical TVS diodes connected to each pin. Any two pins may be connected to vulnerable lines, while the third pin is connected to ground. This gives the designer maximum flexibility in pcb routing. These devices feature extremely good ESD protection characteristics highlighted by low dynamic resistance, low peak ESD clamping voltage, and high ESD withstand voltage (+/-12kV contact per IEC 61000-4-2).

uClamp0512ZA is in a 3-pin SLP0603P3X3F package. It measures 0.62 x 0.32 mm with a nominal height of only 0.25mm. Leads are finished with lead-free NiAu. The combination of small size and high ESD surge capability makes them ideal for use in portable applications such as cellular phones, digital cameras, and tablets.

Features

- High ESD withstand voltage
 - IEC 61000-4-2 (ESD) 15kV (air), 12kV (contact)
- Very small PCB area
- Protects two data lines
- Working Voltage: 5V
- Low reverse leakage current
- Low ESD peak clamping voltage
- Low dynamic resistance
- Solid-State silicon-avalanche technology

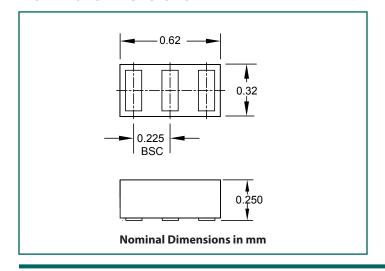
Mechanical Characteristics

- SLP0603P3X3F Package
- Pb-Free, Halogen Free, RoHS/WEEE compliant
- Nominal dimensions: 0.62 x 0.32 x 0.25 mm
- · Lead finish: NiAu
- Marking: Marking code + date code
- Packaging: Tape and Reel

Applications

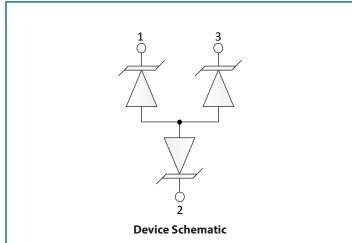
- Cellular Handsets & Accessories
- Keypads, Side Keys, Audio Ports
- Portable Instrumentation
- Notebook Computers
- Tablet PC

Nominal Dimensions



Rev 2.0

Functional Schematic



Absolute Maximum Ratings

Rating	Symbol	Value	Units
Peak Pulse Power (tp = 1.2/50μs)	P _{PK}	30	W
Peak Pulse Current (tp = 1.2/50µs)	I _{PP}	2	A
ESD per IEC 61000-4-2 (Air) ⁽¹⁾	V	±15	kV
ESD per IEC 61000-4-2 (Contact) ⁽¹⁾	V _{ESD}	±12	KV .
Operating Temperature	T _J	-40 to +125	°C
Storage Temperature	T _{STG}	-55 to +150	оС

Electrical Characteristics (T=25°C unless otherwise specified)

Parameter	Symbol	Conditions		Min.	Тур.	Max.	Units
Reverse Stand-Off Voltage	V _{RWM}	-40°C to 125°C Between any two pi	ns			5	V
Reverse Breakdown Voltage	V _{BR}	I _t = 1mA, Between any two pins	-40°C to 125°C	6.5	8	9.5	V
		$V_{RWM} = 5V$	T = 25°C		0.03	0.050	μΑ
Reverse Leakage Current	I _R	Between any two pins	T = 125°C		0.05	0.250	μΑ
Clamping Voltage	V _c	$I_{pp} = 2A$, $tp = 8/20\mu s$, Between any two pins			10.5	15	V
FSD Clamping Voltage ²	V	PP	Pin 1 to 2, Pin 3 to 2		10.5		V
	(TLP) Pin 1 to 3		11		V		
ESD Clamping Voltage ²	V _c	PP	Pin 1 to 2, Pin 3 to 2		17.5		V
LSD Clamping voltage	v _C	(TLP)	Pin 1 to 3		20		V
Dynamic Resistance ^{2, 3}	R _{DYN}	tp = 0.2/100ns (TLP)	Pin 1 to 2, Pin 3 to 2		0.58		Ohms
DYN (1217)		Pin 1 to 3		0.75		Ohms	
Junction Capacitance	C _J	V _R = 0V, f = 1MHz Between any two pins	T = 25°C		5	7	pF

Notes

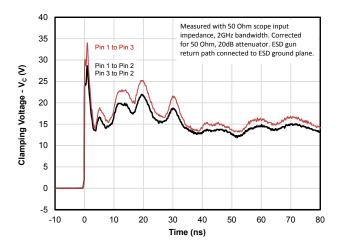
^{(1):} ESD Gun return path to Ground Reference Plane (GRP)

^{(2):} Transmission Line Pulse Test (TLP) Settings: tp = 100ns, tr = 0.2ns, I_{TLP} and V_{TLP} averaging window: t_1 = 70ns to t_2 = 90ns.

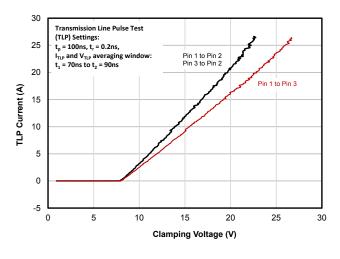
^{(3):} Dynamic resistance calculated from $I_{TIP} = 4A$ to $I_{TIP} = 16A$

Typical Characteristics

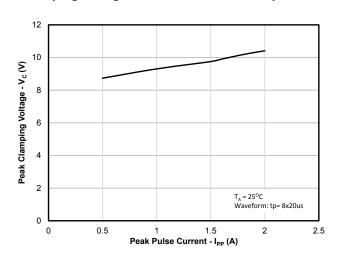
ESD Clamping (+8kV Contact per IEC 61000-4-2)



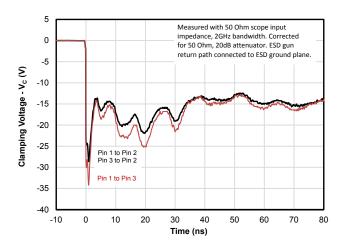
TLP IV Curve (Positive Pulse)



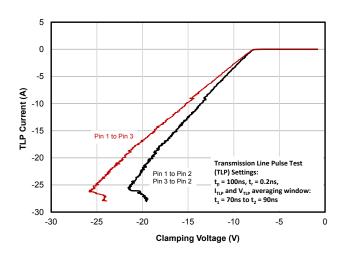
Clamping Voltage vs. Peak Pulse Current (tp=8/20us)



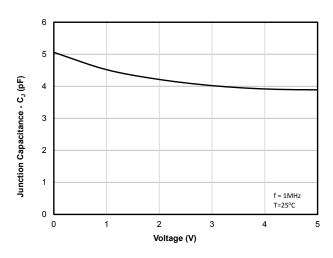
ESD Clamping (-8kV Contact per IEC 61000-4-2)



TLP IV Curve (Negative Pulse)

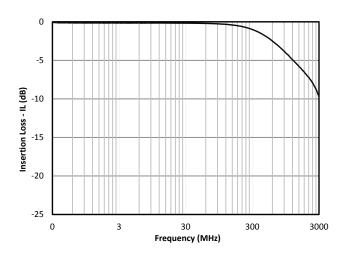


Capacitance vs. Reverse Voltage

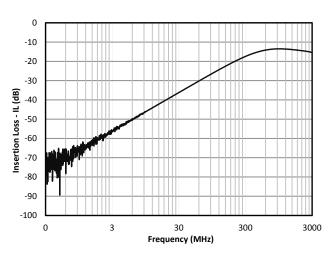


Typical Characteristics (Continued)

Insertion Loss - S21



Analog Crosstalk



Applications Information

Assembly Guidelines

The small size of this device means that some care must be taken during the mounting process to insure reliable solder joint. The figure at the right details Semtech's recommended mounting pattern. Recommended assembly guidelines are shown in Table 1. Note that these are only recommendations and should serve only as a starting point for design since there are many factors that affect the assembly process. Exact manufacturing parameters will require some experimentation to get the desired solder application. Semtech's recommended mounting pattern is based on the following design guidelines:

Land Pattern

The recommended land pattern follows IPC standards and is designed for maximum solder coverage. Detailed dimensions are shown elsewhere in this document.

Solder Stencil

Stencil design is one of the key factors which will determine the volume of solder paste which is deposited onto the land pad. The area ratio of the stencil aperture will determine how well the stencil will print. The area ratio takes into account the aperture shape, aperture size, and stencil thickness. An area ratio of 0.70 – 0.75 is preferred for the subject package. The area ratio of a rectangular aperture is given as:

Area Ratio = (L * W) / (2 * (L + W) * T)

Where:

L = Aperture Length

W = Aperture Width

T = Stencil Thickness

Semtech recommends a stencil thickness of 0.100mm for this device. The stencil should be laser cut with electropolished finish. The stencil should have a positive taper of approximately 5 degrees. Electro polishing and tapering the walls results in reduced surface friction and better paste release. For small pitch components, Semtech recommends a square aperture with rounded corners for consistent solder release. Due to the small aperture size, a solder paste with Type 4 or smaller particles are recommended.

Rev 2.0

Recommended Mounting Pattern

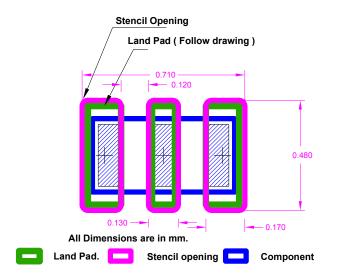
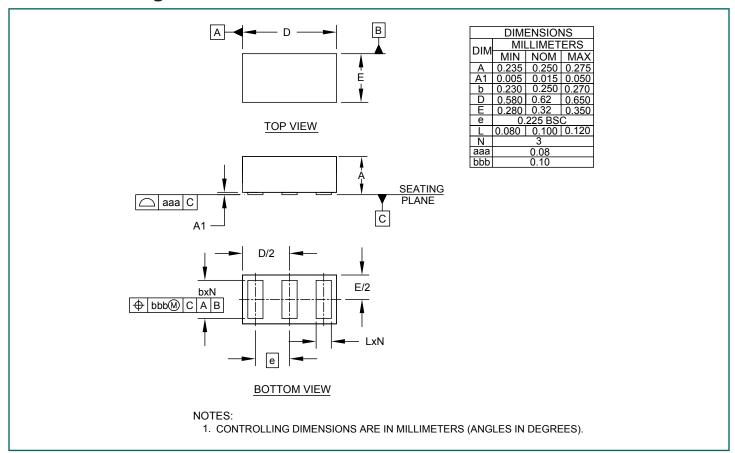


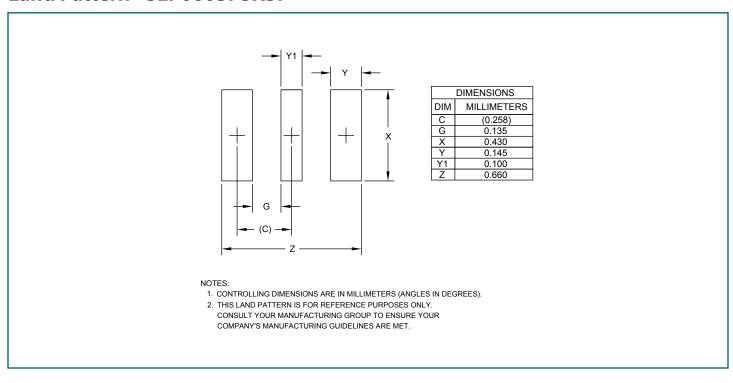
Table 1 - Recommended Assembly Guidelines						
Assembly Parameter	Recommendation					
Solder Stencil Design	Laser Cut, Electro-Polished					
Aperture Shape	Rectangular with rounded					
	corners					
Solder Stencil Thickness	0.100mm (0.004")					
Solder Paste Type	Type 4 size sphere or smaller					
Solder Reflow Profile	Per JEDEC J-STD-020					
PCB Solder pad Design	Non-Solder Mask Defined					
PCB Pad Finish	OSP or NiAu					

Outline Drawing - SLP0603P3X3F

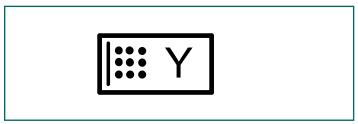


Land Pattern - SLP0603P3X3F

Rev 2.0

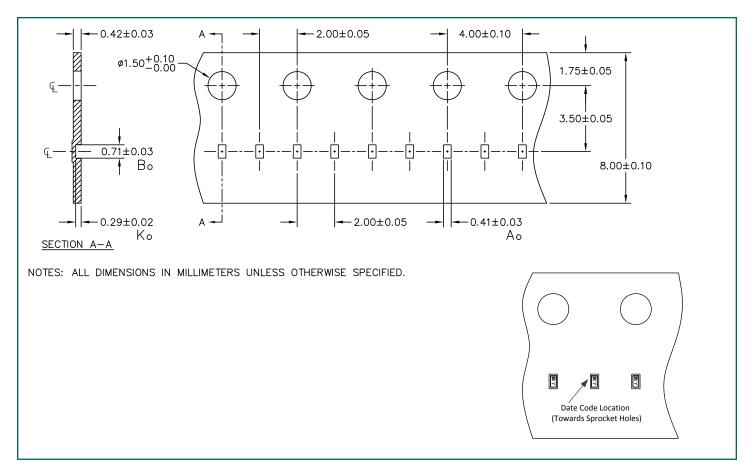


Marking Code



Notes: Device is electrically symmetrical

Tape and Reel Specification



Ordering Information

Part Number	Qty per Reel	Reel Size					
uClamp0512ZATFT	15000	7 Inch					
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Corporation.							



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Businessunit	Protection				
Reljob#	Part_Number, Job Name/Type	Fab, Package	Rel Job Status	Key Dates:	
5929	RClamp1851ZA	Tower	Rel Testing Complete	Job Accepted: 21-Jan-2015	
	New Device Qual	SLP0603P2X3F	Passes All Requirements	Requested CD:	
		GEI GOGGI ZAGI		Actual Start Date: 17-Dec-2014	
	New Product on qualified process and qualified package		•	ECD for Conditional:	
				Job ECD: 19-Mar-2015	

Completed Tasks

1.0 Lot AER2241	AssemblyLot	AER2241	DateCode	1504			
Seq TaskCode	S	SampleSize	Criteria	Complete	Failures	DataSource	Results/Comments
1 Data-Prep	N	lone	None	19-Feb-2015		Camarillo	
2 HTRB_Pre_Elect_150°C_	RT24 2	110	Pass on Zero Fails	20-Feb-2015	0	Camarillo	
3 HTRB_150°C_Real Time	_0024 2	110	Pass on Zero Fails	06-Mar-2015	0	Camarillo	
4 HTRB_Pre_Elect	1	05	Pass on Zero Fails	19-Feb-2015	0	Camarillo	
5 HTRB_150°C_0072	1	05	Pass on Zero Fails	23-Feb-2015	0	Camarillo	
6 HTRB_150°C _0408	1	05	Pass on Zero Fails	06-Mar-2015	0	Camarillo	
7 85/85_Pre Elec	2	20	Pass on Zero Fails	19-Feb-2015	0	Camarillo	
8 85/85_120hr_On/Off	2	20	Pass on Zero Fails	24-Feb-2015	0	Camarillo	
9 Pack_Clos	0	1	0	07-Mar-2015		Camarillo	

Thursday, March 19, 2015

Page 1 of 1

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Businessunit	Protection			
Reljob#	Part_Number, Job Name/Type	Fab, Package	Rel Job Status	Key Dates:
5940	RClamp5031ZA	Tower	Rel Testing Complete	Job Accepted: 21-May-2015
	New Device Qual	SLP0603P2X3F	Passes All Requirements	Requested CD:
				Actual Start Date: 23-Jan-2015
	New Product on qualified process and qualified package		•	ECD for Conditional:
	•			Job ECD: 29-May-2015

Completed Tasks

1.0 Lot AER2297 AssemblyLo	ot AER2297	DateCode	1515		
Seq TaskCode	SampleSize	Criteria	Complete Failu	ures DataSource	Results/Comments
1 Data-Prep	None	None	24-Apr-2015	Camarillo	
2 HTRB_Pre_Elect_150°C_RT24	210	Pass on Zero Fails	01-May-2015	0 Camarillo	
3 HTRB_150°C_Real Time_0024	210	Pass on Zero Fails	21-May-2015 0) Camarillo	
4 HTRB_Pre_Elect	105	Pass on Zero Fails	29-Apr-2015 0) Camarillo	
5 BI_BD_Valid	NA	Meet HTOL Schematics	29-Apr-2015 0) Camarillo	
6 HTRB_150°C_0072	105	Pass on Zero Fails	04-May-2015 0) Camarillo	
7 HTRB_150°C _0408	105	Pass on Zero Fails	18-May-2015 0) Camarillo	
8 85/85_Pre Elec	20	Pass on Zero Fails	29-Apr-2015 0) Camarillo	
9 85/85_120hr_On/Off	20	Pass on Zero Fails	05-May-2015 0) Camarillo	
10 Pack_Clos	0	0	22-May-2015	Camarillo	

Friday, May 29, 2015

Page 1 of 1

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Businessunit	Protection			
Reljob#	Part_Number, Job Name/Type	Fab, Package	Rel Job Status	Key Dates:
6276.2	RCLAMP3331ZA/RCLAMP5011ZA	· · · · · · · · · · · · · · · · · · ·		Job Accepted: 06-Dec-2016
	Process Qual (TJT)	SLP0603P2X3F	Passes All Requirem.ents	Requested CD:
	New Product on un-qualified process with qualified package	ct on un-qualified process with		Actual Start Date: 06-Dec-2016 ECD for Conditional:
9				Job ECD: '02-Mar-2017

Completed Tasks

1.0	Lot AER3682	AssemblyLor	AER3682	DateCode	1647			
	Seq TaskCode		SampleSize	Criteria	Complete	Failures	DataSource	Results/Comments
	1 Data-Prep		None	None	09-Dec-2016		Camarillo	
	2 HTRB_Pre_Elect_150°C	C_RT24	210	Pass on Zero Fails	13-Dec-2016	0	Camarillo	
	3 HTRB_150°C_Real Tim	e_0024	210	Pass on Zero Fails	15-Dec-2016	0	Camarillo	
	4 HTRB_Pre_Elect		105	Pass on Zero Fails	09-Dec-2016	0	Camarillo	
	5 BI_BD_Valid		NA	Meet HTOL Schematics	09-Dec-2016		Camarillo	
	6 HTRB_150°C_0072		105	Pass on Zero Fails	12-Dec-2016	0	Camarillo	
	7 HTRB_150°C _0408		105	Pass on Zero Fails	04-Jan-2017	0	Camarillo	
	8 HTS_Pre_Elect		77	Pass on Zero Fails	09-Dec-2016	0	Camarillo	
	10 HTS_0500		77	Pass on Zero Fails	04-Jan-2017	0	Camarillo	
	11 HTS_1000		77	Pass on Zero Fails	23-Jan-2017	0	Camarillo	
	12 85/85_W/Pre_Pre Elec		20		13-Dec-2016	0	Camarillo	
	13 85°C/85%RH_BD_Valid		20	Pass on Zero Fails	06-Jan-2017		Camarillo	
	14 85/85_120hr_On/Off		20	Pass on Zero Fails	11-Jan-2017	0	Camarillo	
	15 Pre_Elect_Precond		154	Pass on Zero Fails	13-Dec-2016	0	Camarillo	
	16 Precond_Temp_Cyc_5c	ус	154	Pass on Zero Fails	04-Jan-2017	0	Camarillo	

	17 Precond_HTS_24hr	154	Pass on Zero Fails	05-Jan-2017	0	Camarillo	
	18 Precond_85/85_NoElec168hr	154	Pass on Zero Fails	12-Jan-2017	0	Camarillo	
	19 Precond_IR_Refl_Char	154	Pass on Zero Fails	12-Jan-2017	0	Camarillo	
	20 T/C_Pre_Elect	77	Pass on Zero Fails	12-Jan-2017	0	Camarillo	
	21 T/C_wPre_0250	77	Pass on Zero Fails	18-Jan-2017	0	Camarillo	
	22 T/C_wPre_0500	77	Pass on Zero Fails	23-Jan-2017	0	Camarillo	
	23 T/C_wPre_1000	77	Pass on Zero Fails	02-Feb-2017	0	Camarillo	
	23 X_Sect	15	Pass on Zero Fails	24-Feb-2017	0	Camarillo	
	24 85°C/85%RH_W/Pre_Pre Elec	77	Pass on Zero Fails	12-Jan-2017	0	Camarillo	
	25 85°C/85%RH_BD_Valid	77	Pass on Zero Fails	13-Jan-2017	0	Camarillo	
	26 85°C/85%RH_Biased_168hrs	77	Pass on Zero Fails	20-Jan-2017	0	Camarillo	
	27 85°C/85%RH_Biased_500hrs	77	Pass on Zero Fails	03-Feb-2017	0	Camarillo	
	28 85°C/85%RH_Biased_1000hrs	77	Pass on Zero Fails	24-Feb-2017	0	Camarillo	
	28 X_Sect	15	Pass on Zero Fails	24-Feb-2017	0	Camarillo	
	29 Rider_Card_Wash/Bake	154	Pass on Zero Fails	12-Dec-2017	0	Camarillo	
	30 Pack_Clos	0	0	27-Feb-2017		Camarillo	
2.0	Lot AER3318 Assembly	Lot AER3318	DateCode	1648			
	Seq TaskCode	SampleSize	Criteria	Complete	Failures	DataSource	Results/Comments
	1 Data-Prep	None	None	09-Dec-2016		Camarillo	
	2 HTRB_Pre_Elect_150°C_RT24	210	Pass on Zero Fails	13-Dec-2016	0	Camarillo	
	3 HTRB_150°C_Real Time_0024	210	Pass on Zero Fails	14-Dec-2016	0	Camarillo	
	4 HTRB_Pre_Elect	105	Pass on Zero Fails	09-Dec-2016	0	Camarillo	
	5 BI_BD_Valid	NA	Meet HTOL Schematics	09-Dec-2016		Camarillo	
	6 HTRB_150°C_0072	105	Pass on Zero Fails	12-Dec-2016	0	Camarillo	
	7 HTRB_150°C _0408	105	Pass on Zero Fails	04-Jan-2017	0	Camarillo	
	8 HTS_Pre_Elect	77	Pass on Zero Fails	12-Dec-2016	0	Camarillo	
	10 HTS_0500	77	Pass on Zero Fails	04-Jan-2017	0	Camarillo	

11 HTS_1000	77	Pass on Zero Fails	23-Jan-2017	0	Camarillo	
12 85/85_W/Pre_Pre Elec	20	Pass on Zero Fails	13-Dec-2016	0		Camarillo
13 85°C/85%RH_BD_Valid	20	Pass on Zero Fails	06-Jan-2017	0	Camarillo	
14 85/85_120hr_On/Off	20	Pass on Zero Fails	11-Jan-2017	0	Camarillo	
15 Pre_Elect_Precond	154	Pass on Zero Fails	13-Dec-2016	0	Camarillo	
16 Precond_Temp_Cyc_5cyc	154	Pass on Zero Fails	04-Jan-2017	0	Camarillo	
17 Precond_HTS_24hr	154	Pass on Zero Fails	05-Jan-2017	0	Camarillo	
18 Precond_85/85_NoElec168hr	154	Pass on Zero Fails	12-Jan-2017	0	Camarillo	
19 Precond_IR_Refl_Char	154	Pass on Zero Fails	12-Jan-2017	0	Camarillo	
20 T/C_Pre_Elect	77	Pass on Zero Fails	12-Jan-2017	0	Camarillo	
21 T/C_wPre_0250	77	Pass on Zero Fails	18-Jan-2017	0	Camarillo	
22 T/C_wPre_0500	77	Pass on Zero Fails	23-Jan-2017	0	Camarillo	
23 T/C_wPre_1000	77	Pass on Zero Fails	02-Feb-2017	0	Camarillo	
23 X_Sect	15	Pass on Zero Fails	24-Feb-2017	0	Camarillo	
24 85°C/85%RH_W/Pre_Pre Elec	77	Pass on Zero Fails	12-Jan-2017	0	Camarillo	
25 85°C/85%RH_BD_Valid	77	Pass on Zero Fail	13-Jan-2017	0	Camarillo	
26 85°C/85%RH_Biased_168hrs	77	Pass on Zero Fails	20-Jan-2017	0	Camarillo	
27 85°C/85%RH_Biased_500hrs	77	Pass on Zero Fails	03-Feb-2017	0	Camarillo	
28 85°C/85%RH_Biased_1000hrs	77	Pass on Zero Fails	24-Feb-2017	0	Camarillo	
28 X_Sect	15	Pass on Zero Fails	24-Feb-2017	0	Camarillo	
29 Rider_Card_Wash/Bake	154	Pass on Zero Fails	24-Dec-2017	0	Camarillo	
30 Pack_Clos	0	0	27-Feb-2017		Camarillo	
Lot AER3808 Assemb	lyLot AER3808	DateCode	1648			
Seq TaskCode	SampleSize	Criteria	Complete	Failures	DataSource	Results/Comments
1 Data-Prep	None	None	04-Jan-2017	0	Camarillo	
2 HTRB_Pre_Elect_150°C_RT24	100	Pass on Zero Fails	10-Jan-2017	0	Camarillo	
Z TTTKB_FTE_LIECT_130 C_KTZ4						

4 HTRB_Pre_Elect	105	Pass on Zero Fails	10-Jan-2017	0	Camarillo
5 BI_BD_Valid	NA	Meet HTOL Schematics	10-Jan-2017	0	Camarillo
6 HTRB_150°C_0072	105	Pass on Zero Fails	13-Jan-2017	0	Camarillo
7 HTRB_150°C _0408	105	Pass on Zero Fails	27-Jan-2017	0	Camarillo
8 HTS_Pre_Elect	77	Pass on Zero Fails	09-Jan-2017	0	Camarillo
9 HTS_0168	77	Pass on Zero Fails	16-Jan-2017	0	Camarillo
10 HTS_0500	77	Pass on Zero Fails	30-Jan-2017	0	Camarillo
11 HTS_1000	77	Pass on Zero Fails	22-Feb-2017	0	Camarillo
12 85/85_W/Pre_Pre Elec	20	Pass on Zero Fails	10-Jan-2017	0	Camarillo
13 85°C/85%RH_BD_Valid	20	Pass on Zero Fails	11-Jan-2017	0	Camarillo
14 85/85_120hr_On/Off	20	Pass on Zero Fails	16-Jan-2017	0	Camarillo
15 Pre_Elect_Precond	154	Pass on Zero Fails	09-Jan-2017	0	Camarillo
16 Precond_Temp_Cyc_5cyc	154	Pass on Zero Fails	09-Jan-2017	0	Camarillo
17 Precond_HTS_24hr	154	Pass on Zero Fails	10-Jan-2017	0	Camarillo
18 Precond_85/85_NoElec168hr	154	Pass on Zero Fails	17-Jan-2017	0	Camarillo
19 Precond_IR_Refl_Char	154	Pass on Zero Fails	17-Jan-2017	0	Camarillo
20 T/C_Pre_Elect	77	Pass on Zero Fails	17-Jan-2017	0	Camarillo
21 T/C_wPre_0250	77	Pass on Zero Fails	23-Jan-2017	0	Camarillo
22 T/C_wPre_0500	77	Pass on Zero Fails	30-Jan-2017	0	Camarillo
23 T/C_wPre_1000	77	Pass on Zero Fails	07-Feb-2017	0	Camarillo
23 X_Sect	15	Pass on Zero Fails	11-Mar-2017	0	Camarillo
24 85°C/85%RH_W/Pre_Pre Elec	77	Pass on Zero Fails	17-Jan-2017	0	Camarillo
25 85°C/85%RH_BD_Valid	77	Pass on Zero Fails	18-Jan-2017	0	Camarillo
26 85°C/85%RH_Biased_168hrs	77	Pass on Zero Fails	16-Jan-2017	0	Camarillo
27 85°C/85%RH_Biased_500hrs	77	Pass on Zero Fails	18-Feb-2017	0	Camarillo
28 85°C/85%RH_Biased_1000hrs	77	Pass on Zero Fails	11-Mar-2017	0	Camarilloo
28 X_Sect	15		01-Mar-2017		Camarillo

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 29 Rider_Card_Wash/Bake
 154
 05-Jan-2017
 0
 Camarillo

 30 Pack_Clos
 0
 0
 02-Mar-2017
 Camarillo

Tuesday, March 14, 2017

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Businessunit	Protection			
Reljob#	Part_Number, Job Name/Type	Fab, Package	Rel Job Status	Key Dates:
6074	RClamp0542ZA			Job Accepted: 09-Oct-2015
	New Device Qual	SLP0603P3X3F	Passes All Requirements	Requested CD:
		02. 0000. 07.0.		Actual Start Date: 30-Sep-2015
	New Product on qualified process and qualified package		•	ECD for Conditional:
				Job ECD: 10-Nov-2015

Completed Tasks

I.0 Lot AER2729 AssemblyLo	ot AER2729	DateCode	1538	
Seq TaskCode	SampleSize	Criteria	Complete Failures	DataSource Results/Comments
1 Data-Prep	None	None	13-Oct-2015	Camarillo
2 HTRB_Pre_Elect_150°C_RT24	105	Pass on Zero Fails	13-Oct-2015 0	Camarillo
3 HTRB_150°C_Real Time_0024	105	Pass on Zero Fails	16-Oct-2015 0	Camarillo
4 HTRB_Pre_Elect	105	Pass on Zero Fails	13-Oct-2015 0	Camarillo
5 HTRB_150°C_0072	105	Pass on Zero Fails	16-Oct-2015 0	Camarillo
6 HTRB_150°C _0408	105	Pass on Zero Fails	30-Oct-2015 0	Camarillo
7 85/85_Pre Elec	20	Pass on Zero Fails	13-Oct-2015 0	Camarillo
8 85/85_120hr_On/Off	20	Pass on Zero Fails	20-Oct-2015 0	Camarillo
12 Pack_Clos	0	0	10-Nov-2015	Camarillo

Friday, December 11, 2015

Page 1 of 1

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Businessunit	Protection				
Reljob#	Part_Number, Job Name/Type	Fab, Package	Rel Job Status	Key Dates:	
6045	uClamp0512ZA	ASMC12TVS	Rel Testing Complete	Job Accepted: 06-Aug-2015	
	uClamp0512ZA New Device / Package Qualif	SLP0603P3X3F	Passes All Requirements	Requested CD:	
	,	02. 0000. 07.0.		Actual Start Date: 06-Aug-2015	
	New Product on qualified process with unqualified package		•	ECD for Conditional:	
				Job ECD: 04-Dec-2015	

Completed Tasks

1.0 Lot GDA416600 Assembly	Lot AER-002558	DateCode	1531		
Seq TaskCode	SampleSize	Criteria	Complete	Failures	DataSource Results/Comments
1 Data-Prep	None	None	14-Aug-2015		Camarillo
2 HTRB Pre Ele 150°C RT24 B	210	Pass on Zero Fails	18-Aug-2015	0	Camarillo
3 HTRB_150°C_Real Time_0024	210	Pass on Zero Fails	20-Aug-2015	0	Camarillo
4 HTRB_Pre_Elect	105	Pass on Zero Fails	17-Aug-2015	0	Camarillo
5 BI_BD_Valid	NA	Meet HTOL Schematics	18-Aug-2015	0	Camarillo
6 HTRB_150°C_0072	105	Pass on Zero Fails	21-Aug-2015	0	Camarillo
7 HTRB_150°C _0408	105	Pass on Zero Fails	04-Sep-2015	0	Camarillo
8 HTS_Pre_Elect	77	Pass on Zero Fails	17-Aug-2015	0	Camarillo
9 HTS_0168	77	Pass on Zero Fails	24-Aug-2015	0	Camarillo
10 HTS_0500	77	Pass on Zero Fails	08-Sep-2015	0	Camarillo
11 HTS_1000	77	Pass on Zero Fails	28-Sep-2015	0	Camarillo
12 Pre_Conditioning_Level_1	NA	MSL 1	17-Aug-2015	0	Camarillo
13 Rider_Card_Wash/Bake	NA		17-Aug-2015	0	Camarillo
14 Pre_Elect_Precond	154	Pass on Zero Fails	18-Aug-2015	0	Camarillo
15 Precond_Temp_Cyc_5cyc	154	Pass on Zero Fails	18-Aug-2015	0	Camarillo

16 Precond_HTS_24hr	154	Pass on Zero Fails	19-Aug-2015	0	Camarillo	
17 Precond_85/85_NoElec168hr	154	Pass on Zero Fails	26-Aug-2015	0	Camarillo	
18 Precond_260°C_IR_Ref_Char	154	Pass on Zero Fails	26-Aug-2015	0	Camarillo	
19 T/C_Pre_Elect	77	Pass on Zero Fails	26-Aug-2015	0	Camarillo	
20 T/C_wPre_0250	77	Pass on Zero Fails	01-Sep-2015	0	Camarillo	
21 T/C_wPre_0500	77	Pass on Zero Fails	08-Sep-2015	0	Camarillo	
22 T/C_wPre_1000	77	Pass on Zero Fails	16-Sep-2015	0	Camarillo	
23 Pre_Elect_Precond	77	Pass on Zero Fails	25-Sep-2015	0	Camarillo	
24 Precond_Temp_Cyc_5cyc	77	Pass on Zero Fails	28-Sep-2015	0	Camarillo	
25 Precond_HTS_24hr	77	Pass on Zero Fails	29-Sep-2015	0	Camarillo	
26 Precond_85/85_NoElec168hr	77	Pass on Zero Fails	06-Oct-2015	0	Camarillo	
27 Precond_260°C_IR_Ref_Char	77	Pass on Zero Fails	06-Oct-2015	0	Camarillo	
28 85/85_W/Pre_Pre Elec	77	Pass on Zero Fails	06-Oct-2015	0	Camarillo	
29 85°C/85%RH_BD_Valid	77	Pass on Zero Fails	05-Oct-2015	0	Camarillo	
30 85°C/85%RH_Biased_168hrs	77	Pass on Zero Fails	03-Nov-2015	2	Camarillo	Rel. Eng.: Submitted to FA (FA-004024)
31 85°C/85%RH_Biased_500hrs	75	Pass on Zero Fails	17-Nov-2015	0	Camarillo	Rel. Eng.: Submitted to FA (FA-004024)
32 85°C/85%RH_Biased_1000hrs	43	Pass on Zero Fails	18-Nov-2015	0	Camarillo	
33 Construct_Package	5 unique packaged devices minimum.	No Major Findings, Q&R to review construction analysis report.	21-Sep-2015		Camarillo	
34 FA_85/85_0168hr	3	FAs must be resolved, resulting in discounting the failure or corrective action taken.	03-Nov-2015	2	Camarillo	Rel. Eng.:FA indicated that A board issue was identified as well as a chemical reaction was responsible for the corrosion. Group agreed to rerun and follow up with ORT and CAR (CAR-001285). Release this qual on condition of the new material qual pass.
35 FA_85/85_0500hr	12	FAs must be resolved, resulting in discounting the failure or corrective action taken.	17-Nov-2015	12	Camarillo	Rel. Eng.:FA indicated that A board issue was identified as well as a chemical reaction was responsible for the corrosion. Group agreed to rerun and follow up with ORT and CAR (CAR-001285). Release this qual on condition of the new material qual pass.
36 Pack_Clos	0	0	19-Nov-2015		Camarillo	

Lot GDA416600 Assemb	lyLot AER-002559	DateCode	1531		
Seq TaskCode	SampleSize	Criteria	Complete	Failures	DataSource Results/Comments
1 Data-Prep	None	None	14-Aug-2015		Camarillo
2 HTRB Pre Ele 150°C RT24 B	210	Pass on Zero Fails	20-Aug-2015	0	Camarillo
3 HTRB_150°C_Real Time_0024	210	Pass on Zero Fails	25-Aug-2015	0	Camarillo
4 HTRB_Pre_Elect	105	Pass on Zero Fails	17-Aug-2015	0	Camarillo
5 BI_BD_Valid	NA	Meet HTOL Schematics	18-Aug-2015	0	Camarillo
6 HTRB_150°C_0072	105	Pass on Zero Fails	21-Aug-2015	0	Camarillo
7 HTRB_150°C _0408	105	Pass on Zero Fails	04-Sep-2015	0	Camarillo
8 HTS_Pre_Elect	77	Pass on Zero Fails	17-Aug-2015	0	Camarillo
9 HTS_0168	77	Pass on Zero Fails	24-Aug-2015	0	Camarillo
10 HTS_0500	77	Pass on Zero Fails	08-Sep-2015	0	Camarillo
11 HTS_1000	77	Pass on Zero Fails	28-Sep-2015	0	Camarillo
12 Pre_Conditioning_Level_1	NA	MSL 1	17-Aug-2015	0	Camarillo
13 Rider_Card_Wash/Bake	NA		17-Aug-2015	0	Camarillo
14 Pre_Elect_Precond	154	Pass on Zero Fails	18-Aug-2015	0	Camarillo
15 Precond_Temp_Cyc_5cyc	154	Pass on Zero Fails	18-Aug-2015	0	Camarillo
16 Precond_HTS_24hr	154	Pass on Zero Fails	19-Aug-2015	0	Camarillo
17 Precond_85/85_NoElec168hr	154	Pass on Zero Fails	26-Aug-2015	0	Camarillo
18 Precond_260°C_IR_Ref_Char	154	Pass on Zero Fails	26-Aug-2015	0	Camarillo
19 T/C_Pre_Elect	77	Pass on Zero Fails	26-Aug-2015	0	Camarillo
20 T/C_wPre_0250	77	Pass on Zero Fails	01-Sep-2015	0	Camarillo
21 T/C_wPre_0500	77	Pass on Zero Fails	08-Sep-2015	0	Camarillo
22 T/C_wPre_1000	77	Pass on Zero Fails	16-Sep-2015	0	Camarillo
23 Pre_Elect_Precond	77	Pass on Zero Fails	25-Sep-2015	0	Camarillo
24 Precond_Temp_Cyc_5cyc	77	Pass on Zero Fails	28-Sep-2015	0	Camarillo
25 Precond_HTS_24hr	77	Pass on Zero Fails	29-Sep-2015	0	Camarillo

26 Precond_85/85_NoElec168hr	77	Pas	ss on Zero Fails	06-Oct-2015	0	Camarillo	
27 Precond_260°C_IR_Ref_Char	77	Pas	ss on Zero Fails	06-Oct-2015	0	Camarillo	
28 85/85_W/Pre_Pre Elec	77	Pas	ss on Zero Fails	06-Oct-2015	0	Camarillo	
29 85°C/85%RH_BD_Valid	77	Pas	ss on Zero Fails	05-Oct-2015	0	Camarillo	
30 85°C/85%RH_Biased_168hrs	77	Pas	s on Zero Fails	03-Nov-2015	3	Camarillo	Rel. Eng.: Submitted to FA (FA-004024)
31 85°C/85%RH_Biased_500hrs	74	Pas	s on Zero Fails	17-Nov-2015	16	Camarillo	Rel. Eng.: Submitted to FA (FA-004024)
32 85°C/85%RH_Biased_1000hrs	32	Pas	s on Zero Fails	18-Nov-2015	0		Camarillo
33 FA_85/85_0168hr	3	reso diso failu	s must be olved, resulting in counting the ure or corrective ion taken.	03-Nov-2015	3	Camarillo	Rel. Eng.:FA indicated that A board issue wa identified as well as a chemical reaction was responsible for the corrosion. Group agreed trerun and follow up with ORT and CAR (CAR 001285). Release this qual on condition of the new material qual pass.
34 FA_85/85_0500hr	16		s must be olved, resulting in	17-Nov-2015	16	Camarillo	Rel. Eng.:FA indicated that A board issue wa identified as well as a chemical reaction was
		failu	counting the ure or corrective on taken.				rerun and follow up with ORT and CAR (CAR 001285). Release this qual on condition of th
35 Pack_Clos	0	failu	ure or corrective	19-Nov-2015		Camarillo	responsible for the corrosion. Group agreed to rerun and follow up with ORT and CAR (CAR 001285). Release this qual on condition of the new material qual pass.
		failu acti	ure or corrective	19-Nov-2015 1531		Camarillo	rerun and follow up with ORT and CAR (CAR 001285). Release this qual on condition of th
		failu acti 0 NER-002560	ure or corrective ion taken.				rerun and follow up with ORT and CAR (CAR 001285). Release this qual on condition of th
D Lot GDA416600 Asso	emblyLot A	failu acti 0 NER-002560	DateCode	1531	Failures		rerun and follow up with ORT and CAR (CAR 001285). Release this qual on condition of th new material qual pass.
Lot GDA416600 Associated Seq TaskCode	emblyLot A	failu acti 0 AER-002560 leSize Cri. Nor	DateCode	1531 Complete	Failures	DataSource	rerun and follow up with ORT and CAR (CAR 001285). Release this qual on condition of th new material qual pass.
Description Lot GDA416600 Associated Seq TaskCode 1 Data-Prep	emblyLot Al Sample None 210	failu acti 0 AER-002560 MeSize Cri. Nor	DateCode steria	1531 <i>Complete</i> 14-Aug-2015	Failures 0	DataSource Camarillo	rerun and follow up with ORT and CAR (CAR 001285). Release this qual on condition of th new material qual pass.
Seq TaskCode 1 Data-Prep 2 HTRB Pre Ele 150°C RT24 B	emblyLot Al Sample None 210	failu acti 0 AER-002560 JeSize Cri. Nor Pas	DateCode teria ne ss on Zero Fails	1531 <i>Complete</i> 14-Aug-2015 20-Aug-2015	Failures 0 0	DataSource Camarillo Camarillo	rerun and follow up with ORT and CAR (CAF 001285). Release this qual on condition of th new material qual pass.
Description of the second sequence of the sequ	emblyLot Al Sample None 210 4 210	failu acti 0 AER-002560 Nor Pas Pas Med	DateCode teria ne ss on Zero Fails	1531 Complete 14-Aug-2015 20-Aug-2015 26-Aug-2015	Failures 0 0 0	DataSource Camarillo Camarillo Camarillo	rerun and follow up with ORT and CAR (CAF 001285). Release this qual on condition of th new material qual pass.
Def GDA416600 Associated Seq TaskCode 1 Data-Prep 2 HTRB Pre Ele 150°C RT24 B 3 HTRB_150°C_Real Time_0024 4 HTRB_Pre_Elect	None 210 4 210 105	failu acti 0 NER-002560 Nor Pas Pas Pas Mec	DateCode Iteria ne ss on Zero Fails ss on Zero Fails st on Zero Fails st on Zero Fails	1531 Complete 14-Aug-2015 20-Aug-2015 26-Aug-2015 17-Aug-2015	Failures 0 0 0 0	DataSource Camarillo Camarillo Camarillo Camarillo	rerun and follow up with ORT and CAR (CAF 001285). Release this qual on condition of th new material qual pass.
Description of the second sequence of the sequ	emblyLot Al Sample None 210 4 210 105 NA	failu acti 0 NER-002560 Nor Pas Pas Pas Mee Scr	DateCode teria ne ss on Zero Fails ss on Zero Fails et HTOL nematics	1531 Complete 14-Aug-2015 20-Aug-2015 26-Aug-2015 17-Aug-2015 18-Aug-2015	### Comparison of Comparison o	DataSource Camarillo Camarillo Camarillo Camarillo Camarillo	rerun and follow up with ORT and CAR (CAR 001285). Release this qual on condition of th new material qual pass.
Def GDA416600 Associated Seq TaskCode 1 Data-Prep 2 HTRB Pre Ele 150°C RT24 B 3 HTRB_150°C_Real Time_0024 4 HTRB_Pre_Elect 5 BI_BD_Valid 6 HTRB_150°C_0072	**EmblyLot All **Sample** None	failu acti 0 AER-002560 Nor Pas Pas Mer Sch Pas	DateCode Iteria ne ss on Zero Fails ss on Zero Fails et HTOL nematics ss on Zero Fails	1531 Complete 14-Aug-2015 20-Aug-2015 26-Aug-2015 17-Aug-2015 18-Aug-2015 21-Aug-2015	Failures 0 0 0 0 0 0 0	DataSource Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo	rerun and follow up with ORT and CAR (CAF 001285). Release this qual on condition of th new material qual pass.
Description	**EmblyLot All **Sample** None	failu acti 0 AER-002560 IeSize Cri. Nor Pas Pas Med Scr. Pas Pas	DateCode Iteria The Ses on Zero Fails	1531 Complete 14-Aug-2015 20-Aug-2015 26-Aug-2015 17-Aug-2015 18-Aug-2015 21-Aug-2015 04-Sep-2015	Failures 0 0 0 0 0 0 0 0	DataSource Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo	rerun and follow up with ORT and CAR (CAR 001285). Release this qual on condition of th new material qual pass.

11 HTS_1000	77	Pass on Zero Fails	28-Sep-2015	0	Camarillo	
12 Pre_Conditioning_Level_1	NA	MSL 1	17-Aug-2015	0	Camarillo	
13 Rider_Card_Wash/Bake	NA		17-Aug-2015	0	Camarillo	
14 Pre_Elect_Precond	154	Pass on Zero Fails	18-Aug-2015	0	Camarillo	
15 Precond_Temp_Cyc_5cyc	154	Pass on Zero Fails	18-Aug-2015	0	Camarillo	
16 Precond_HTS_24hr	154	Pass on Zero Fails	19-Aug-2015	0	Camarillo	
17 Precond_85/85_NoElec168hr	154	Pass on Zero Fails	26-Aug-2015	0	Camarillo	
18 Precond_260°C_IR_Ref_Char	154	Pass on Zero Fails	26-Aug-2015	0	Camarillo	
19 T/C_Pre_Elect	77	Pass on Zero Fails	26-Aug-2015	0	Camarillo	
20 T/C_wPre_0250	77	Pass on Zero Fails	01-Sep-2015	0	Camarillo	
21 T/C_wPre_0500	77	Pass on Zero Fails	08-Sep-2015	0	Camarillo	
22 T/C_wPre_1000	77	Pass on Zero Fails	16-Sep-2015	0	Camarillo	
23 Pre_Elect_Precond	77	Pass on Zero Fails	25-Sep-2015	0	Camarillo	
24 Precond_Temp_Cyc_5cyc	77	Pass on Zero Fails	28-Sep-2015	0	Camarillo	
25 Precond_HTS_24hr	77	Pass on Zero Fails	29-Sep-2015	0	Camarillo	
26 Precond_85/85_NoElec168hr	77	Pass on Zero Fails	06-Oct-2015	0	Camarillo	
27 Precond_260°C_IR_Ref_Char	77	Pass on Zero Fails	06-Oct-2015	0	Camarillo	
28 85/85_W/Pre_Pre Elec	77	Pass on Zero Fails	06-Oct-2015	0	Camarillo	
29 85°C/85%RH_BD_Valid	77	Pass on Zero Fails	05-Oct-2015	0	Camarillo	
30 85°C/85%RH_Biased_168hrs	77	Pass on Zero Fails	03-Nov-2015	1	Camarillo	Rel. Eng.: Submitted to FA (FA-004024)
31 85°C/85%RH_Biased_500hrs	76	Pass on Zero Fails	17-Nov-2015	0	Camarillo	Rel. Eng.: No new failure.
32 85°C/85%RH_Biased_1000hrs	40	Pass on Zero Fails	03-Dec-2015	2	Camarillo	Rel. Eng.: Submitted to FA (FA-004024)
33 FA_85/85_0168hr	1	FAs must be resolved, resulting in discounting the failure or corrective action taken.	03-Nov-2015	1	Camarillo	Rel. Eng.:FA indicated that A board issue was identified as well as a chemical reaction was responsible for the corrosion. Group agreed to rerun and follow up with ORT and CAR (CAR-001285). Release this qual on condition of the new material qual pass.

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34 FA_85/85_1000hr	2	FAs must be resolved, resulting in discounting the failure or corrective action taken.	03-Dec-2015	2	Camarillo	Rel. Eng.:FA indicated that A board issue was identified as well as a chemical reaction was responsible for the corrosion. Group agreed to rerun and follow up with ORT and CAR (CAR-001285). Release this qual on condition of the new material qual pass.
35 Pack_Clos	0	0	04-Dec-2015		Camarillo	

Friday, December 04, 2015

Page 6 of 6